

## OPAx196 36V 低功耗、低偏移电压、轨至轨运算放大器

### 1 特性

- 低偏移电压:  $\pm 100\mu\text{V}$  (最大值)
- 低偏移电压漂移:  $\pm 0.5\mu\text{V}/^\circ\text{C}$  (典型值)
- 低偏置电流:  $\pm 5\text{pA}$  (典型值)
- 高共模抑制: 140dB
- 低噪声: 1kHz 时为  $15\text{nV}/\sqrt{\text{Hz}}$
- 轨至轨输入和输出
- 可提供电源轨的差分输入电压范围
- 高带宽: 2.5MHz GBW
- 低静态电流: 每个放大器为  $140\mu\text{A}$  (典型值)
- 宽电源范围:  $\pm 2.25\text{V}$  至  $\pm 18\text{V}$ , 4.5V 至 36V
- 已过滤电磁干扰 (EMI)/射频干扰 (RFI) 的输入
- 高电容负载驱动能力: 1nF
- 行业标准封装:
  - SOIC-8、SOT-5 和 VSSOP-8 单体封装
  - SOIC-8 和 VSSOP-8 双列封装
  - SOIC-14、TSSOP-14 和 QFN-16 四列封装

### 2 应用

- 多路复用数据采集系统
- 测试和测量设备
- 高分辨率模数转换器 (ADC) 驱动器放大器
- SAR ADC 基准缓冲器
- 模拟输入和输出模块
- 高侧和低侧电流感应
- 高精度比较器
- 医疗仪器

### 3 说明

OPAx196 系列 (OPA196、OPA2196 和 OPA4196) 是新一代 36V 轨至轨 e-trim™ 运算放大器。

这些器件在整个输出范围内提供非常低的偏移电压 (典型值为  $\pm 25\mu\text{V}$ )、漂移 (典型值为  $\pm 0.5\mu\text{V}/^\circ\text{C}$ ) 和低偏置电流 (典型值为  $\pm 5\text{pA}$ )，同时还具有非常低的静态电流 (典型值为  $140\mu\text{A}/\text{通道}$ )。

OPAx196 拥有诸多独一无二的特性，例如可提供电源轨的差分输入电压范围、高输出电流 ( $\pm 65\text{mA}$ ) 以及高达 1nF 的高电容负载驱动能力，是稳健耐用的高性能运算放大器，适用于各种高电压工业应用。

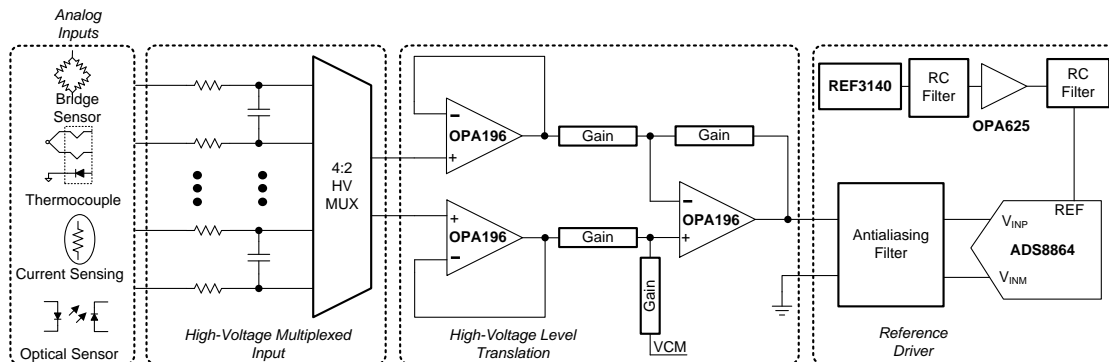
OPAx196 系列运算放大器采用标准封装，在  $-40^\circ\text{C}$  至  $+125^\circ\text{C}$  的额定温度范围内工作。

器件信息<sup>(1)</sup>

| 器件型号    | 封装                 | 封装尺寸 (标称值)      |
|---------|--------------------|-----------------|
| OPA196  | SOIC (8)           | 4.90mm x 3.90mm |
|         | 小外形尺寸晶体管 (SOT) (5) | 2.90mm x 1.60mm |
|         | VSSOP (8)          | 3.00mm x 3.00mm |
| OPA2196 | SOIC (8)           | 4.90mm x 3.90mm |
|         | VSSOP (8)          | 3.00mm x 3.00mm |
| OPA4196 | SOIC (14)          | 8.65mm x 3.90mm |
|         | TSSOP (14)         | 5.00mm x 4.40mm |

(1) 要了解所有可用封装，请参见数据表末尾的封装选项附录。

### OPA196 应用于高压多路复用数据采集系统



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## 目录

|          |  |           |           |   |           |
|----------|--|-----------|-----------|---|-----------|
| <b>1</b> | 特性 .....   | <b>1</b>  | 7.3       | Feature Description .....                   | <b>19</b> |
| <b>2</b> | 应用 .....   | <b>1</b>  | 7.4       | Device Functional Modes .....               | <b>26</b> |
| <b>3</b> | 说明 .....   | <b>1</b>  | <b>8</b>  | <b>Application and Implementation .....</b> | <b>27</b> |
| <b>4</b> | 修订历史记录 .....   | <b>2</b>  | 8.1       | Application Information .....               | <b>27</b> |
| <b>5</b> | <b>Pin Configuration and Functions .....</b>   | <b>3</b>  | 8.2       | Typical Applications .....                  | <b>27</b> |
| <b>6</b> | <b>Specifications .....</b>  | <b>5</b>  | <b>9</b>  | <b>Power-Supply Recommendations .....</b>   | <b>31</b> |
| 6.1      | Absolute Maximum Ratings .....   | <b>5</b>  | <b>10</b> | <b>Layout .....</b>                         | <b>31</b> |
| 6.2      | ESD Ratings .....  | <b>5</b>  | 10.1      | Layout Guidelines .....                     | <b>31</b> |
| 6.3      | Recommended Operating Conditions .....   | <b>5</b>  | 10.2      | Layout Example .....                        | <b>32</b> |
| 6.4      | Thermal Information: OPA196 .....  | <b>5</b>  | <b>11</b> | <b>器件和文档支持 .....</b>                        | <b>33</b> |
| 6.5      | Thermal Information: OPA2196 .....   | <b>6</b>  | 11.1      | 器件支持 .....                                  | <b>33</b> |
| 6.6      | Thermal Information: OPA4196 .....   | <b>6</b>  | 11.2      | 文档支持 .....                                  | <b>33</b> |
| 6.7      | Electrical Characteristics: $V_S = \pm 4\text{ V}$ to $\pm 18\text{ V}$ ( $V_S = 8\text{ V}$ to $36\text{ V}$ ) .....    | <b>7</b>  | 11.3      | 相关链接 .....                                  | <b>33</b> |
| 6.8      | Electrical Characteristics: $V_S = \pm 2.25\text{ V}$ to $\pm 4\text{ V}$ ( $V_S = 4.5\text{ V}$ to $8\text{ V}$ ) ..... | <b>9</b>  | 11.4      | 接收文档更新通知 .....                              | <b>33</b> |
| 6.9      | Typical Characteristics .....  | <b>11</b> | 11.5      | 社区资源 .....                                  | <b>34</b> |
| <b>7</b> | <b>Detailed Description .....</b>  | <b>18</b> | 11.6      | 商标 .....                                    | <b>34</b> |
| 7.1      | Overview .....   | <b>18</b> | 11.7      | 静电放电警告 .....                                | <b>34</b> |
| 7.2      | Functional Block Diagram .....   | <b>18</b> | 11.8      | Glossary .....                              | <b>34</b> |
|          |  |           | <b>12</b> | <b>机械、封装和可订购信息 .....</b>                    | <b>34</b> |

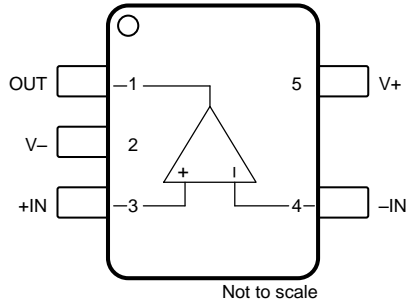
## 4 修订历史记录

注：之前版本的页码可能与当前版本有所不同。

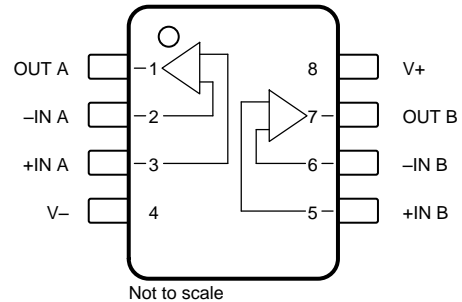
| 日期         | 修订版本 | 注意     |
|------------|------|--------|
| 2017 年 7 月 | *    | 最初发布版本 |

## 5 Pin Configuration and Functions

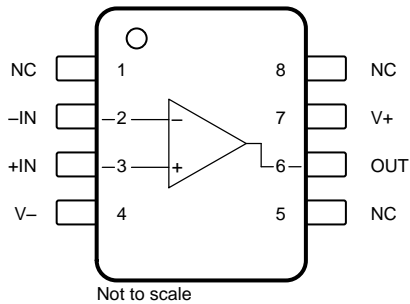
**DBV Package: OPA196  
5-Pin SOT  
Top View**



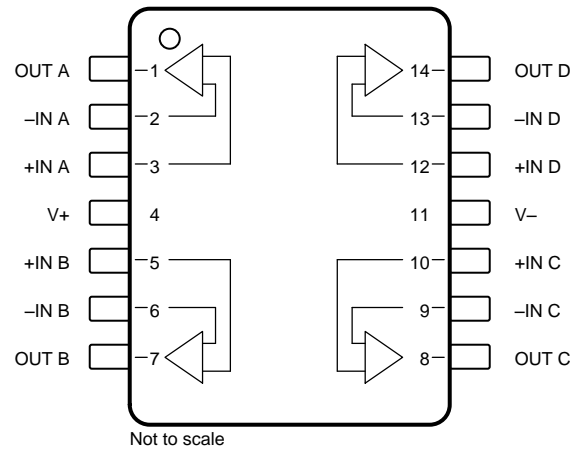
**D and DGK Packages: OPA2196  
8-Pin SOIC and VSSOP  
Top View**



**D and DGK Packages: OPA196  
8-Pin SOIC and VSSOP  
Top View**



**D and PW Packages: OPA4196  
14-Pin SOIC and TSSOP  
Top View**



(1) NC = No internal connection.

**Pin Functions: OPA196**

| NAME | PIN                      |           | I/O | DESCRIPTION                                   |
|------|--------------------------|-----------|-----|---|
|      | OPA196                   |           |     |   |
|      | D (SOIC),<br>DGK (VSSOP) | DBV (SOT) |     |   |
| +IN  | 3                        | 3         | I   | Noninverting input                            |
| –IN  | 2                        | 4         | I   | Inverting input                               |
| NC   | 1, 5, 8                  | —         | —   | No internal connection (can be left floating) |
| OUT  | 6                        | 1         | O   | Output  |
| V+   | 7                        | 5         | —   | Positive (highest) power supply               |
| V–   | 4                        | 2         | —   | Negative (lowest) power supply                |

**Pin Functions: OPA2196 and OPA4196**

| NAME  | PIN                      |                         | I/O | DESCRIPTION                     |
|-------|--------------------------|-------------------------|-----|---------------------------------|
|       | OPA2196                  | OPA4196                 |     |                                 |
|       | D (SOIC),<br>DGK (VSSOP) | D (SOIC),<br>PW (TSSOP) |     |                                 |
| +IN A | 3                        | 3                       | I   | Noninverting input, channel A   |
| +IN B | 5                        | 5                       | I   | Noninverting input, channel B   |
| +IN C | —                        | 10                      | I   | Noninverting input, channel C   |
| +IN D | —                        | 12                      | I   | Noninverting input, channel D   |
| –IN A | 2                        | 2                       | I   | Inverting input, channel A      |
| –IN B | 6                        | 6                       | I   | Inverting input, channel B      |
| –IN C | —                        | 9                       | I   | Inverting input, channel C      |
| –IN D | —                        | 13                      | I   | Inverting input, channel D      |
| OUT A | 1                        | 1                       | O   | Output, channel A               |
| OUT B | 7                        | 7                       | O   | Output, channel B               |
| OUT C | —                        | 8                       | O   | Output, channel C               |
| OUT D | —                        | 14                      | O   | Output, channel D               |
| V+    | 8                        | 4                       | —   | Positive (highest) power supply |
| V–    | 4                        | 11                      | —   | Negative (lowest) power supply  |

## 6 Specifications

### 6.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted)<sup>(1)</sup>

|                                     |                    |              | MIN               | MAX                         | UNIT       |
|-------------------------------------|--------------------|--------------|-------------------|-----------------------------|------------|
| Supply voltage, $V_S = (V+) - (V-)$ |                    |              |                   | ±20<br>(+40, single supply) | V          |
| Signal input pins                   | Voltage            | Common-mode  | (V-) - 0.5        | (V+) + 0.5                  | V          |
|                                     |                    | Differential | (V+) - (V-) + 0.2 |                             |            |
| Current                             |                    |              | ±10               |                             | mA         |
| Output short circuit <sup>(2)</sup> |                    |              | Continuous        | Continuous                  | Continuous |
| Temperature                         | Operating          | -40          |                   | 150                         | °C         |
|                                     | Junction           |              |                   | 150                         |            |
|                                     | Storage, $T_{stg}$ | -65          |                   | 150                         |            |

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.
- (2) Short-circuit to ground, one amplifier per package.

### 6.2 ESD Ratings

|             |                         |         |  | VALUE | UNIT |
|-------------|-------------------------|---------|--|-------|------|
| $V_{(ESD)}$ | Electrostatic discharge | OPAx196 | Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 <sup>(1)</sup>              | ±3000 | V    |
| $V_{(ESD)}$ | Electrostatic discharge | OPA196  | Charged-device model (CDM), per JEDEC specification JESD22-C101 <sup>(2)</sup> | ±1000 | V    |
|             |                         | OPA2196 |  | ±500  | V    |
|             |                         | OPA4196 |  | ±500  | V    |

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
- (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|                                     | MIN         | NOM | MAX      | UNIT |
|-------------------------------------|-------------|-----|----------|------|
| Supply voltage, $V_S = (V+) - (V-)$ | 4.5 (±2.25) |     | 36 (±18) | V    |
| Specified temperature               | -40         |     | 125      | °C   |

### 6.4 Thermal Information: OPA196

| THERMAL METRIC <sup>(1)</sup> |  | OPA196   |             |           | UNIT |
|-------------------------------|--|----------|-------------|-----------|------|
|                               |  | 8 PINS   |             | 5 PINS    |      |
|                               |  | D (SOIC) | DGK (VSSOP) | DBV (SOT) |      |
| $R_{\theta JA}$               | Junction-to-ambient thermal resistance       | 115.8    | 180.4       | 158.8     | °C/W |
| $R_{\theta JC(top)}$          | Junction-to-case(top) thermal resistance     | 60.1     | 67.9        | 60.7      | °C/W |
| $R_{\theta JB}$               | Junction-to-board thermal resistance         | 56.4     | 102.1       | 44.8      | °C/W |
| $\Psi_{JT}$                   | Junction-to-top characterization parameter   | 12.8     | 10.4        | 1.6       | °C/W |
| $\Psi_{JB}$                   | Junction-to-board characterization parameter | 55.9     | 100.3       | 4.2       | °C/W |
| $R_{\theta JC(bot)}$          | Junction-to-case(bottom) thermal resistance  | N/A      | N/A         | N/A       | °C/W |

- (1) For more information about traditional and new thermal metrics, see the *Semiconductor and IC Package Thermal Metrics* application report.

## 6.5 Thermal Information: OPA2196

| THERMAL METRIC <sup>(1)</sup> |  | OPA2196  |             | UNIT |
|-------------------------------|--|----------|-------------|------|
|                               |  | 8 PINS   |             |      |
|                               |  | D (SOIC) | DGK (VSSOP) |      |
| $R_{\theta JA}$               | Junction-to-ambient thermal resistance       | 107.9    | 158         | °C/W |
| $R_{\theta JC(top)}$          | Junction-to-case(top) thermal resistance     | 53.9     | 48.6        | °C/W |
| $R_{\theta JB}$               | Junction-to-board thermal resistance         | 48.9     | 78.7        | °C/W |
| $\Psi_{JT}$                   | Junction-to-top characterization parameter   | 6.6      | 3.9         | °C/W |
| $\Psi_{JB}$                   | Junction-to-board characterization parameter | 48.3     | 77.3        | °C/W |
| $R_{\theta JC(bot)}$          | Junction-to-case(bottom) thermal resistance  | N/A      | N/A         | °C/W |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.6 Thermal Information: OPA4196

| THERMAL METRIC <sup>(1)</sup> |  | OPA4196  |            | UNIT |
|-------------------------------|--|----------|------------|------|
|                               |  | 14 PINS  |            |      |
|                               |  | D (SOIC) | PW (TSSOP) |      |
| $R_{\theta JA}$               | Junction-to-ambient thermal resistance       | 86.4     | 92.6       | °C/W |
| $R_{\theta JC(top)}$          | Junction-to-case(top) thermal resistance     | 46.3     | 27.5       | °C/W |
| $R_{\theta JB}$               | Junction-to-board thermal resistance         | 41.0     | 33.6       | °C/W |
| $\Psi_{JT}$                   | Junction-to-top characterization parameter   | 11.3     | 1.9        | °C/W |
| $\Psi_{JB}$                   | Junction-to-board characterization parameter | 40.7     | 33.1       | °C/W |
| $R_{\theta JC(bot)}$          | Junction-to-case(bottom) thermal resistance  | N/A      | N/A        | °C/W |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## 6.7 Electrical Characteristics: $V_S = \pm 4\text{ V to } \pm 18\text{ V}$ ( $V_S = 8\text{ V to } 36\text{ V}$ )

at  $T_A = 25^\circ\text{C}$ ,  $V_{CM} = V_{OUT} = V_S / 2$ , and  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$  (unless otherwise noted)

| PARAMETER                 |                              | TEST CONDITIONS   |  | MIN   | TYP       | MAX                          | UNIT                                 |
|---------------------------|------------------------------|---|--|---|-----------|------------------------------|--------------------------------------|
| <b>OFFSET VOLTAGE</b>     |                              |   |  |   |           |                              |                                      |
| $V_{OS}$                  | Input offset voltage         | $V_S = \pm 18\text{ V}$   |  |   | $\pm 25$  | $\pm 100$                    | $\mu\text{V}$                        |
|                           |                              | $(V+) - 3.0\text{ V} < V_{CM} < (V+) - 1.5\text{ V}$  |  | See <a href="#">Common-Mode Voltage Range</a> |           |                              |                                      |
|                           |                              | $V_S = \pm 18\text{ V}$ ,<br>$V_{CM} = (V+) - 1.5\text{ V}$   |  |   | $\pm 25$  | $\pm 100$                    |                                      |
| $dV_{OS}/dT$              | Input offset voltage drift   | $V_S = \pm 18\text{ V}$ , $V_{CM} = (V+) - 3\text{ V}$  | $T_A = -40^\circ\text{C to } +125^\circ\text{C}$ |   | $\pm 0.5$ |                              | $\mu\text{V}/^\circ\text{C}$         |
|                           |                              | $V_S = \pm 18\text{ V}$ , $V_{CM} = (V+) - 1.5\text{ V}$  |  |   | $\pm 0.8$ |                              |                                      |
| PSRR                      | Power-supply rejection ratio | $T_A = -40^\circ\text{C to } +125^\circ\text{C}$  |  |   | $\pm 0.3$ | $\pm 1$                      | $\mu\text{V}/\text{V}$               |
| <b>INPUT BIAS CURRENT</b> |                              |   |  |   |           |                              |                                      |
| $I_B$                     | Input bias current           |   |  |   | $\pm 5$   | $\pm 20$                     | pA                                   |
| $I_{OS}$                  | Input offset current         |   |  |   | $\pm 2$   | $\pm 20$                     | pA                                   |
| <b>NOISE</b>              |                              |   |  |   |           |                              |                                      |
| $E_n$                     | Input voltage noise          | $(V-) - 0.1\text{ V} < V_{CM} < (V+) - 3\text{ V}$  | $f = 0.1\text{ Hz to } 10\text{ Hz}$             |   | 1.4       |                              | $\mu\text{V}_{PP}$                   |
|                           |                              | $(V+) - 1.5\text{ V} < V_{CM} < (V+) + 0.1\text{ V}$  | $f = 0.1\text{ Hz to } 10\text{ Hz}$             |   | 7         |                              |                                      |
| $e_n$                     | Input voltage noise density  | $(V-) - 0.1\text{ V} < V_{CM} < (V+) - 3\text{ V}$  | $f = 100\text{ Hz}$                              |   | 18        |                              | $\text{nV}/\sqrt{\text{Hz}}$         |
|                           |                              |   | $f = 1\text{ kHz}$                               |   | 15        |                              |                                      |
|                           |                              | $(V+) - 1.5\text{ V} < V_{CM} < (V+) + 0.1\text{ V}$  | $f = 100\text{ Hz}$                              |   | 53        |                              |                                      |
|                           |                              |   | $f = 1\text{ kHz}$                               |   | 24        |                              |                                      |
| $i_n$                     | Input current noise density  | $f = 1\text{ kHz}$  |  |   | 1.5       | $\text{fA}/\sqrt{\text{Hz}}$ |                                      |
| <b>INPUT VOLTAGE</b>      |                              |   |  |   |           |                              |                                      |
| $V_{CM}$                  | Common-mode voltage range    |   |  | $(V-) - 0.1$                                  |           | $(V+) + 0.1$                 | V                                    |
| CMRR                      | Common-mode rejection ratio  | $V_S = \pm 18\text{ V}$ ,<br>$(V-) - 0.1\text{ V} < V_{CM} < (V+) - 3\text{ V}$                               |  | 120   | 140       |                              | dB                                   |
|                           |                              | $V_S = \pm 18\text{ V}$ ,<br>$(V-) < V_{CM} < (V+) - 3\text{ V}$  | $T_A = -40^\circ\text{C to } +125^\circ\text{C}$ | 114   | 126       |                              |                                      |
|                           |                              | $V_S = \pm 18\text{ V}$ ,<br>$(V+) - 1.5\text{ V} < V_{CM} < (V+)$  |  | 96  | 120       |                              |                                      |
|                           |                              | $(V+) - 3\text{ V} < V_{CM} < (V+) - 1.5\text{ V}$  | $T_A = -40^\circ\text{C to } +125^\circ\text{C}$ | 86  | 100       |                              |                                      |
|                           |                              |   |  | See <a href="#">Typical Characteristics</a>   |           |                              |                                      |
| <b>INPUT IMPEDANCE</b>    |                              |   |  |   |           |                              |                                      |
| $Z_{ID}$                  | Differential                 |   |  | 100    1.6                                    |           |                              | $\text{M}\Omega \parallel \text{pF}$ |
| $Z_{IC}$                  | Common-mode                  |   |  | 1    6.4                                      |           |                              | $10^{13}\Omega \parallel \text{pF}$  |
| <b>OPEN-LOOP GAIN</b>     |                              |   |  |   |           |                              |                                      |
| $A_{OL}$                  | Open-loop voltage gain       | $V_S = \pm 18\text{ V}$ ,<br>$(V-) + 0.6\text{ V} < V_O < (V+) - 0.6\text{ V}$ ,<br>$R_L = 2\text{ k}\Omega$  |  | 124   | 134       |                              | dB                                   |
|                           |                              |   | $T_A = -40^\circ\text{C to } +125^\circ\text{C}$ | 114   | 126       |                              |                                      |
|                           |                              | $V_S = \pm 18\text{ V}$ ,<br>$(V-) + 0.3\text{ V} < V_O < (V+) - 0.3\text{ V}$ ,<br>$R_L = 10\text{ k}\Omega$ |  | 126   | 140       |                              |                                      |
|                           |                              |   | $T_A = -40^\circ\text{C to } +125^\circ\text{C}$ | 120   | 134       |                              |                                      |

**Electrical Characteristics:  $V_S = \pm 4\text{ V}$  to  $\pm 18\text{ V}$  ( $V_S = 8\text{ V}$  to  $36\text{ V}$ ) (continued)**

 at  $T_A = 25^\circ\text{C}$ ,  $V_{CM} = V_{OUT} = V_S / 2$ , and  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$  (unless otherwise noted)

| PARAMETER                 |                                   | TEST CONDITIONS   |  | MIN   | TYP   | MAX | UNIT             |
|---------------------------|-----------------------------------|---|--|---|---|-----|------------------|
| <b>FREQUENCY RESPONSE</b> |                                   |   |  |   |   |     |                  |
| GBW                       | Unity gain bandwidth              |   |  |   | 2.5   |     | MHz              |
| SR                        | Slew rate                         | $V_S = \pm 18\text{ V}$ , $G = 1$ , 10-V step                           | Rising                                       |   | 7.5   |     | V/ $\mu\text{s}$ |
|                           |                                   |   | Falling                                      |   | 5.5   |     |                  |
| $t_s$                     | Settling time                     | To 0.01%, $C_L = 20\text{ pF}$  | $V_S = \pm 18\text{ V}$ , $G = 1$ , 2-V step |   | 0.7   |     | $\mu\text{s}$    |
|                           |                                   |   | $V_S = \pm 18\text{ V}$ , $G = 1$ , 5-V step |   | 1   |     |                  |
|                           |                                   | To 0.001%, $C_L = 20\text{ pF}$   | $V_S = \pm 18\text{ V}$ , $G = 1$ , 2-V step |   | 1.8   |     |                  |
|                           |                                   |   | $V_S = \pm 18\text{ V}$ , $G = 1$ , 5-V step |   | 3.7   |     |                  |
| $t_{OR}$                  | Overload recovery time            | $V_{IN} \times G = V_S$   | From overload to negative rail               |   | 0.4   |     | $\mu\text{s}$    |
|                           |                                   |   | From overload to positive rail               |   | 1   |     |                  |
| THD+N                     | Total harmonic distortion + noise | $G = 1$ , $f = 1\text{ kHz}$ , $V_O = 3.5\text{ V}_{RMS}$               |  |   | 0.0012%                                     |     |                  |
|                           | Crosstalk                         | OPA2196 and OPA4196, at dc  |  |   | 150   |     | dB               |
|                           |                                   | OPA2196 and OPA4196, $f = 100\text{ kHz}$                               |  |   | 130   |     | dB               |
| <b>OUTPUT</b>             |                                   |   |  |   |   |     |                  |
| $V_O$                     | Voltage output swing from rail    | Positive rail   | No load                                      |   | 5   | 15  | $\text{mV}$      |
|                           |                                   |   | $R_L = 10\text{ k}\Omega$                    |   | 50  | 110 |                  |
|                           |                                   |   | $R_L = 2\text{ k}\Omega$                     |   | 200   | 500 |                  |
|                           |                                   | Negative rail   | No load                                      |   | 5   | 15  |                  |
|                           |                                   |   | $R_L = 10\text{ k}\Omega$                    |   | 50  | 110 |                  |
|                           |                                   |   | $R_L = 2\text{ k}\Omega$                     |   | 200   | 500 |                  |
| $I_{SC}$                  | Short-circuit current             | $V_S = \pm 18\text{ V}$   |  |   | $\pm 65$                                    |     | mA               |
| $C_L$                     | Capacitive load drive             |   |  |   | See <a href="#">Typical Characteristics</a> |     |                  |
| $Z_O$                     | Open-loop output impedance        | $f = 1\text{ MHz}$ , $I_O = 0\text{ A}$ , See <a href="#">Figure 19</a> |  |   | 700   |     | $\Omega$         |
| <b>POWER SUPPLY</b>       |                                   |   |  |   |   |     |                  |
| $I_Q$                     | Quiescent current per amplifier   | $I_O = 0\text{ A}$  |  |   | 140   | 200 | $\mu\text{A}$    |
|                           |                                   |   |  | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$ |   | 250 |                  |
| <b>TEMPERATURE</b>        |                                   |   |  |   |   |     |                  |
|                           | Thermal protection                |   |  |   | 180   |     | $^\circ\text{C}$ |
|                           | Thermal hysteresis                |   |  |   | 30  |     | $^\circ\text{C}$ |



## 6.8 Electrical Characteristics: $V_S = \pm 2.25\text{ V}$ to $\pm 4\text{ V}$ ( $V_S = 4.5\text{ V}$ to $8\text{ V}$ )

at  $T_A = +25^\circ\text{C}$ ,  $V_{CM} = V_{OUT} = V_S / 2$ , and  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$  (unless otherwise noted)

| PARAMETER                 |                              | TEST CONDITIONS  |  | MIN   | TYP                    | MAX   | UNIT                                 |
|---------------------------|------------------------------|--|--|---|------------------------|---|--------------------------------------|
| <b>OFFSET VOLTAGE</b>     |                              |  |  |   |                        |   |                                      |
| $V_{OS}$                  | Input offset voltage         | $V_S = \pm 2.25\text{ V}$ ,<br>$V_{CM} = (V+) - 3\text{ V}$  |  |   | $\pm 25$               | $\pm 100$                                   | $\mu\text{V}$                        |
|                           |                              | $(V+) - 3.0\text{ V} < V_{CM} < (V+) - 1.5\text{ V}$   |  | See <a href="#">Common-Mode Voltage Range</a> |                        |   |                                      |
|                           |                              | $V_S = \pm 3\text{ V}$ ,<br>$V_{CM} = (V+) - 1.5\text{ V}$   |  |   | $\pm 25$               | $\pm 100$                                   |                                      |
| $dV_{OS}/dT$              | Input offset voltage drift   | $V_S = \pm 2.25\text{ V}$ , $V_{CM} = (V+) - 3\text{ V}$<br>$V_S = \pm 2.25\text{ V}$ , $V_{CM} = (V+) - 1.5\text{ V}$ | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$                                      |   | $\pm 0.5$<br>$\pm 0.5$ |   | $\mu\text{V}/^\circ\text{C}$         |
| PSRR                      | Power-supply rejection ratio | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$ , $V_{CM} = V_S / 2 - 0.75\text{ V}$                                 |  |   | $\pm 1$                |   | $\mu\text{V}/\text{V}$               |
| <b>INPUT BIAS CURRENT</b> |                              |  |  |   |                        |   |                                      |
| $I_B$                     | Input bias current           |  |  |   | $\pm 5$                | $\pm 20$                                    | $\text{pA}$                          |
| $I_{OS}$                  | Input offset current         |  |  |   | $\pm 2$                | $\pm 20$                                    | $\text{pA}$                          |
| <b>NOISE</b>              |                              |  |  |   |                        |   |                                      |
| $E_n$                     | Input voltage noise          | $(V-) - 0.1\text{ V} < V_{CM} < (V+) - 3\text{ V}$<br>$(V+) - 1.5\text{ V} < V_{CM} < (V+) + 0.1\text{ V}$             | $f = 0.1\text{ Hz}$ to $10\text{ Hz}$<br>$f = 0.1\text{ Hz}$ to $10\text{ Hz}$         |   | 1.4<br>7               |   | $\mu\text{V}_{PP}$                   |
| $e_n$                     | Input voltage noise density  | $(V-) - 0.1\text{ V} < V_{CM} < (V+) - 3\text{ V}$<br>$(V+) - 1.5\text{ V} < V_{CM} < (V+) + 0.1\text{ V}$             | $f = 100\text{ Hz}$<br>$f = 1\text{ kHz}$<br>$f = 100\text{ Hz}$<br>$f = 1\text{ kHz}$ |   | 18<br>15<br>53<br>24   |   | $\text{nV}/\sqrt{\text{Hz}}$         |
| $i_n$                     | Input current noise density  | $f = 1\text{ kHz}$   |  |   | 1.5                    |   | $\text{fA}/\sqrt{\text{Hz}}$         |
| <b>INPUT VOLTAGE</b>      |                              |  |  |   |                        |   |                                      |
| $V_{CM}$                  | Common-mode voltage range    |  |  | $(V-) - 0.1$                                  |                        | $(V+) + 0.1$                                | $\text{V}$                           |
| CMRR                      | Common-mode rejection ratio  | $V_S = \pm 2.25\text{ V}$ ,<br>$(V-) - 0.1\text{ V} < V_{CM} < (V+) - 3\text{ V}$                                      |  | 96  | 110                    |   | dB                                   |
|                           |                              | $V_S = \pm 2.25\text{ V}$ ,<br>$(V-) < V_{CM} < (V+) - 3\text{ V}$   | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$                                      | 90  | 104                    |   |                                      |
|                           |                              | $V_S = \pm 2.25\text{ V}$ ,<br>$(V+) - 1.5\text{ V} < V_{CM} < (V+)$   |  | 96  | 120                    |   |                                      |
|                           |                              | $(V+) - 3\text{ V} < V_{CM} < (V+) - 1.5\text{ V}$   | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$                                      | 84  | 100                    | See <a href="#">Typical Characteristics</a> |                                      |
| <b>INPUT IMPEDANCE</b>    |                              |  |  |   |                        |   |                                      |
| $Z_{ID}$                  | Differential                 |  |  |   | $100 \parallel 1.6$    |   | $\text{M}\Omega \parallel \text{pF}$ |
| $Z_{IC}$                  | Common-mode                  |  |  |   | $1 \parallel 6.4$      |   | $10^{13}\Omega \parallel \text{pF}$  |
| <b>OPEN-LOOP GAIN</b>     |                              |  |  |   |                        |   |                                      |
| $A_{OL}$                  | Open-loop voltage gain       | $V_S = \pm 2.25\text{ V}$ ,<br>$(V-) + 0.6\text{ V} < V_O < (V+) - 0.6\text{ V}$ ,<br>$R_L = 2\text{ k}\Omega$         |  | 110   | 120                    |   | dB                                   |
|                           |                              |  | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$                                      | 100   | 114                    |   |                                      |
|                           |                              | $V_S = \pm 2.25\text{ V}$ ,<br>$(V-) + 0.3\text{ V} < V_O < (V+) - 0.3\text{ V}$ ,<br>$R_L = 10\text{ k}\Omega$        |  | 110   | 126                    |   |                                      |
|                           |                              |  | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$                                      | 106   | 120                    |   |                                      |

**Electrical Characteristics:  $V_S = \pm 2.25\text{ V}$  to  $\pm 4\text{ V}$  ( $V_S = 4.5\text{ V}$  to  $8\text{ V}$ ) (continued)**

 at  $T_A = +25^\circ\text{C}$ ,  $V_{CM} = V_{OUT} = V_S / 2$ , and  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$  (unless otherwise noted)

| PARAMETER                 |                                 | TEST CONDITIONS   |   | MIN   | TYP      | MAX | UNIT             |
|---------------------------|---------------------------------|---|---|---|----------|-----|------------------|
| <b>FREQUENCY RESPONSE</b> |                                 |   |   |   |          |     |                  |
| GBW                       | Unity gain bandwidth            |   |   |   | 2.2      |     | MHz              |
| SR                        | Slew rate                       | $V_S = \pm 2.25\text{V}$ , $G = 1$ , 1-V step                           | Rising  |   | 6.5      |     | V/ $\mu\text{s}$ |
|                           |                                 |   | Falling   |   | 5.5      |     |                  |
| $t_{OR}$                  | Overload recovery time          | $V_{IN} \times G = V_S$   | From overload to negative rail                    |   | 0.4      |     | $\mu\text{s}$    |
|                           |                                 |   | From overload to positive rail                    |   | 1        |     |                  |
|                           | Crosstalk                       | OPA2196 and OPA4196, at dc  |   |   | 150      |     | dB               |
|                           |                                 | OPA2196 and OPA4196, $f = 100\text{ kHz}$                               |   |   | 130      |     | dB               |
| <b>OUTPUT</b>             |                                 |   |   |   |          |     |                  |
| $V_O$                     | Voltage output swing from rail  | Positive rail   | No load   |   | 5        | 15  | mV               |
|                           |                                 |   | $R_L = 10\text{ k}\Omega$                         |   | 15       | 110 |                  |
|                           |                                 |   | $R_L = 2\text{ k}\Omega$                          |   | 60       | 500 |                  |
|                           |                                 | Negative rail   | No load   |   | 5        | 15  |                  |
|                           |                                 |   | $R_L = 10\text{ k}\Omega$                         |   | 15       | 110 |                  |
|                           |                                 |   | $R_L = 2\text{ k}\Omega$                          |   | 60       | 500 |                  |
| $I_{SC}$                  | Short-circuit current           | $V_S = \pm 2.25\text{V}$  |   |   | $\pm 30$ |     | mA               |
| $C_L$                     | Capacitive load drive           |   |   | See <a href="#">Typical Characteristics</a> |          |     |                  |
| $Z_O$                     | Open-loop output impedance      | $f = 1\text{ MHz}$ , $I_O = 0\text{ A}$ , see <a href="#">Figure 19</a> |   |   | 700      |     | $\Omega$         |
| <b>POWER SUPPLY</b>       |                                 |   |   |   |          |     |                  |
| $I_Q$                     | Quiescent current per amplifier | $I_O = 0\text{ A}$  |   |   | 140      | 200 | $\mu\text{A}$    |
|                           |                                 |   | $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$ |   |          | 250 |                  |
| <b>TEMPERATURE</b>        |                                 |   |   |   |          |     |                  |
|                           | Thermal protection              |   |   |   | 180      |     | $^\circ\text{C}$ |
|                           | Thermal hysteresis              |   |   |   | 30       |     | $^\circ\text{C}$ |

## 6.9 Typical Characteristics

Table 1. Table of Graphs

| DESCRIPTION  | FIGURE                                     |
|--|--|
| Offset Voltage vs Common-Mode Voltage                          | Figure 1                                   |
| Open-Loop Gain and Phase vs Frequency                          | Figure 2                                   |
| Closed-Loop Gain and Phase vs Frequency                        | Figure 3                                   |
| Input Bias Current vs Common-Mode Voltage                      | Figure 4                                   |
| Input Bias Current vs Temperature                              | Figure 5                                   |
| Output Voltage Swing vs Output Current (maximum supply)        | Figure 6, Figure 7                         |
| CMRR and PSRR vs Frequency                                     | Figure 8                                   |
| CMRR vs Temperature  | Figure 9                                   |
| PSRR vs Temperature  | Figure 10                                  |
| 0.1-Hz to 10-Hz Noise  | Figure 11                                  |
| Input Voltage Noise Spectral Density vs Frequency              | Figure 12                                  |
| THD+N Ratio vs Frequency                                       | Figure 13                                  |
| THD+N vs Output Amplitude                                      | Figure 14                                  |
| Quiescent Current vs Supply Voltage                            | Figure 15                                  |
| Quiescent Current vs Temperature                               | Figure 16                                  |
| Open Loop Gain vs Temperature                                  | Figure 17, Figure 18                       |
| Open Loop Output Impedance vs Frequency                        | Figure 19                                  |
| Small Signal Overshoot vs Capacitive Load (100-mV output step) | Figure 20, Figure 21                       |
| No Phase Reversal  | Figure 22                                  |
| Overload Recovery  | Figure 23                                  |
| Small-Signal Step Response (100 mV)                            | Figure 24, Figure 25                       |
| Large-Signal Step Response                                     | Figure 26, Figure 27                       |
| Settling Time  | Figure 28, Figure 29, Figure 30, Figure 31 |
| Short-Circuit Current vs Temperature                           | Figure 32                                  |
| Maximum Output Voltage vs Frequency                            | Figure 33                                  |
| Propagation Delay Rising Edge                                  | Figure 34                                  |
| Propagation Delay Falling Edge                                 | Figure 35                                  |

At  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 18\text{ V}$ ,  $V_{CM} = V_S / 2$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$ , and  $C_L = 100\text{ pF}$ , unless otherwise noted.

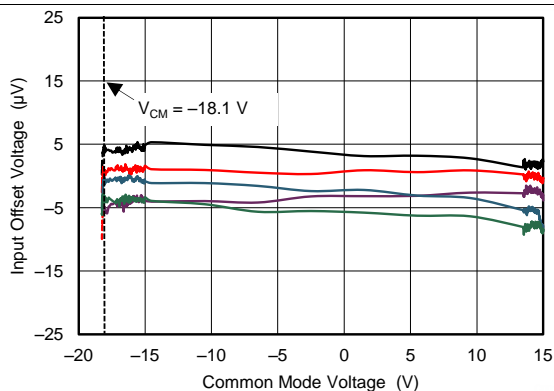


Figure 1. Offset Voltage vs Common-Mode Voltage

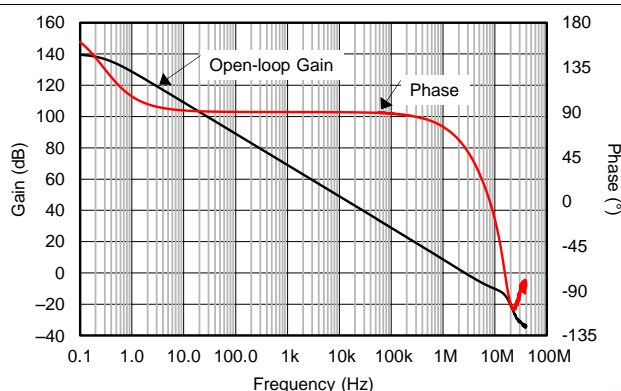


Figure 2. Open-Loop Gain and Phase vs Frequency

At  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 18\text{ V}$ ,  $V_{CM} = V_S / 2$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$ , and  $C_L = 100\text{ pF}$ , unless otherwise noted.

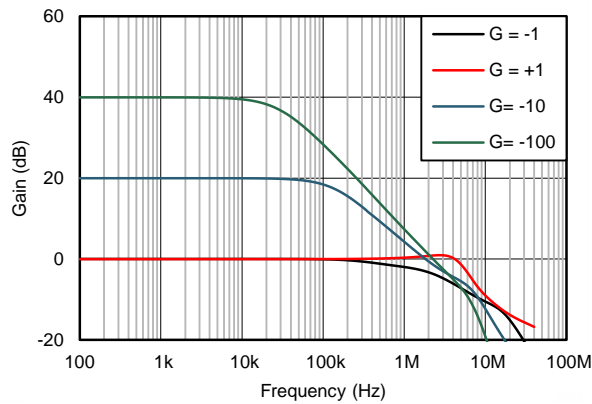


Figure 3. Closed-Loop Gain vs Frequency

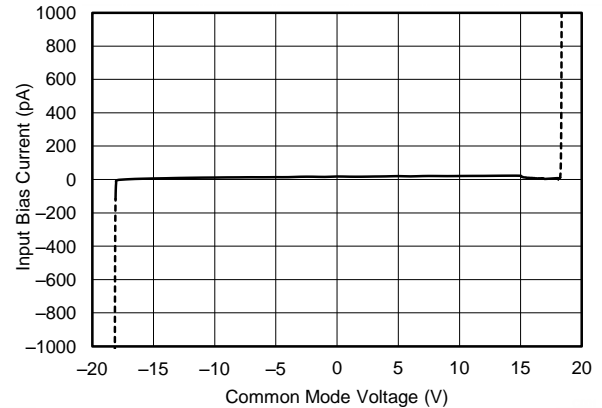


Figure 4. Input Bias Current vs Common-Mode Voltage

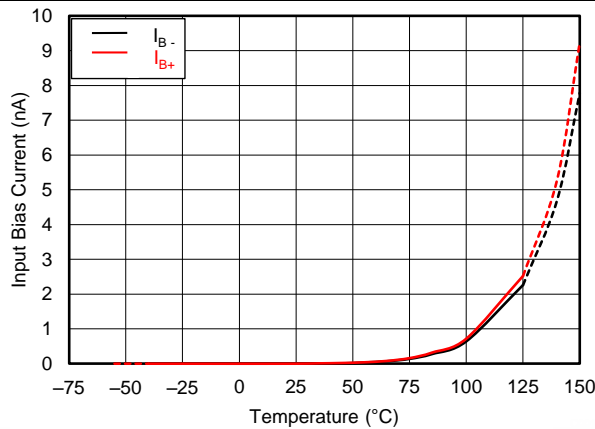


Figure 5. Input Bias Current vs Temperature

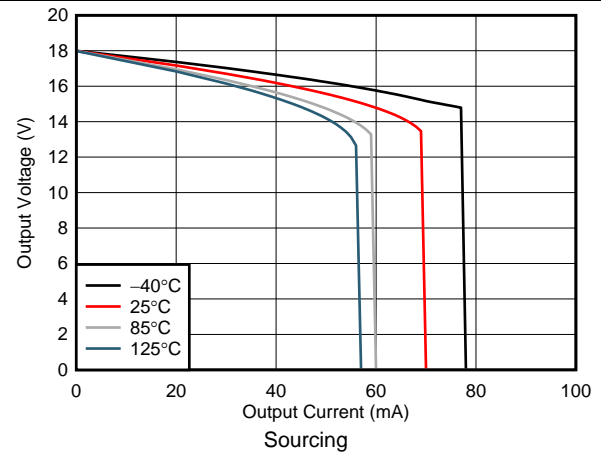


Figure 6. Output Voltage Swing vs Output Current

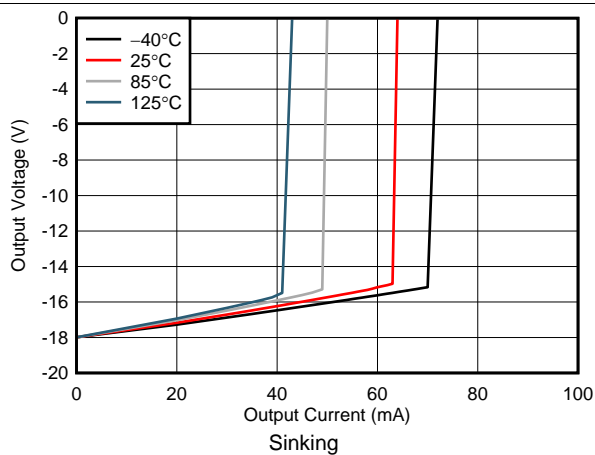


Figure 7. Output Voltage Swing vs Output Current

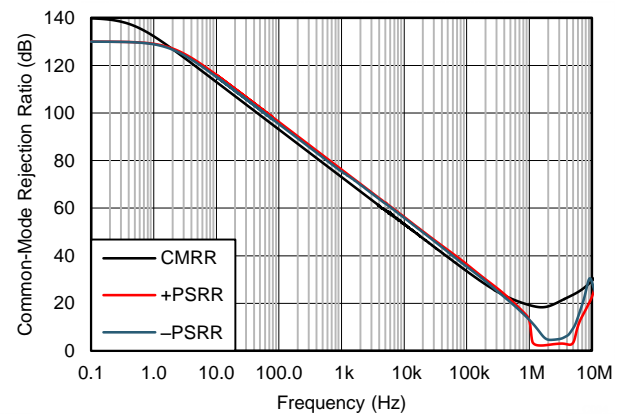


Figure 8. CMRR and PSRR vs Frequency

At  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 18\text{ V}$ ,  $V_{CM} = V_S / 2$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$ , and  $C_L = 100\text{ pF}$ , unless otherwise noted.

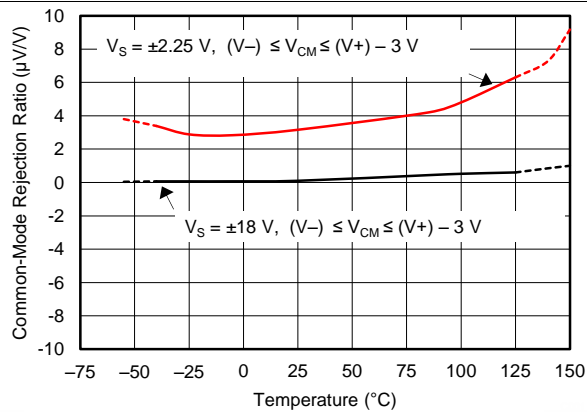


Figure 9. CMRR vs Temperature

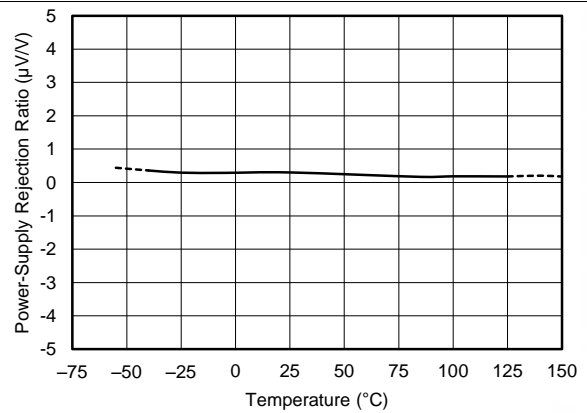


Figure 10. PSRR vs Temperature

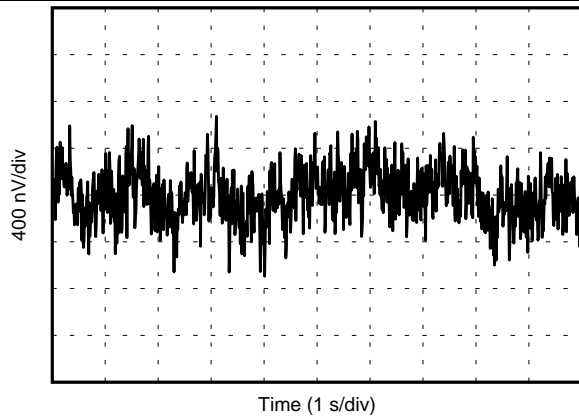


Figure 11. 0.1-Hz to 10-Hz Noise

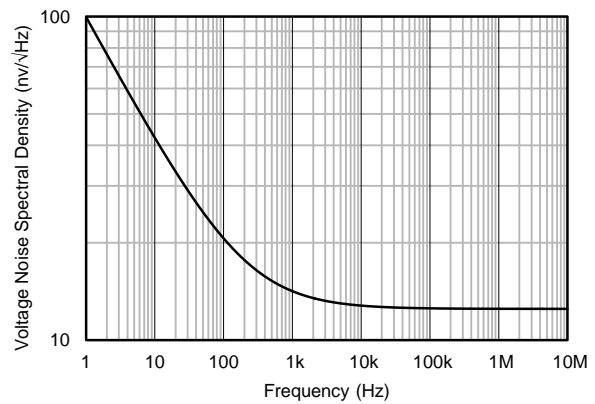


Figure 12. Input Voltage Noise Spectral Density vs Frequency

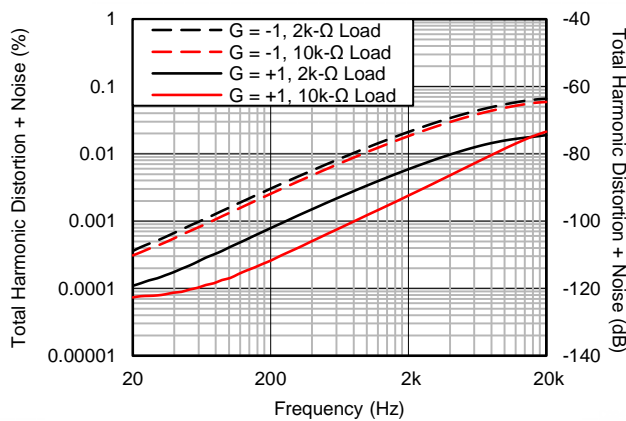


Figure 13. THD+N vs Frequency

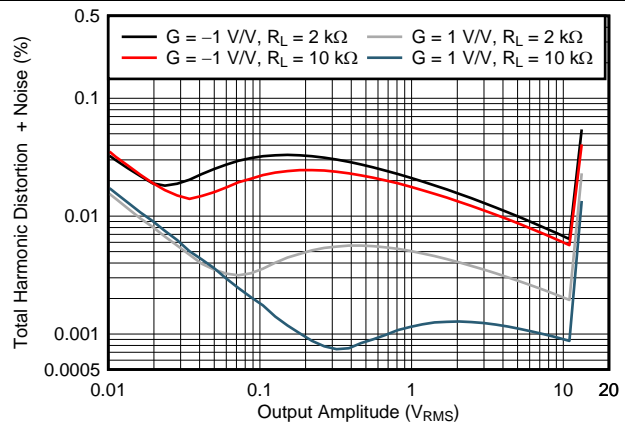


Figure 14. THD+N vs Output Amplitude

At  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 18\text{ V}$ ,  $V_{CM} = V_S / 2$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$ , and  $C_L = 100\text{ pF}$ , unless otherwise noted.

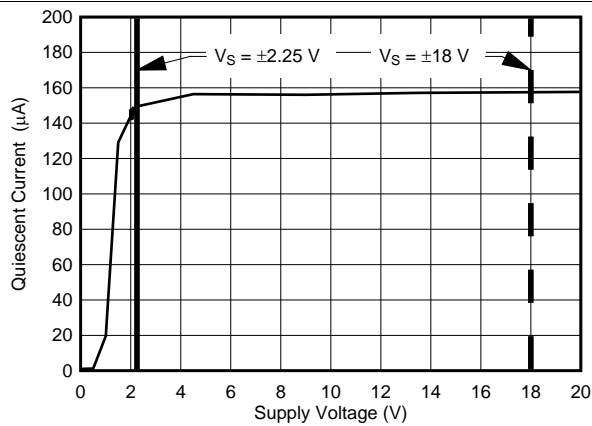


Figure 15. Quiescent Current vs Supply Voltage

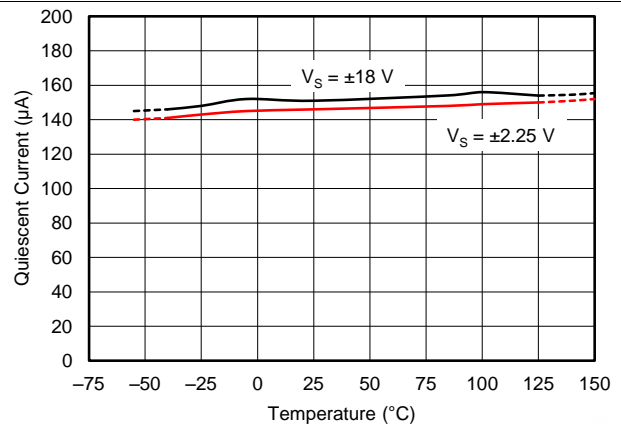


Figure 16. Quiescent Current vs Temperature

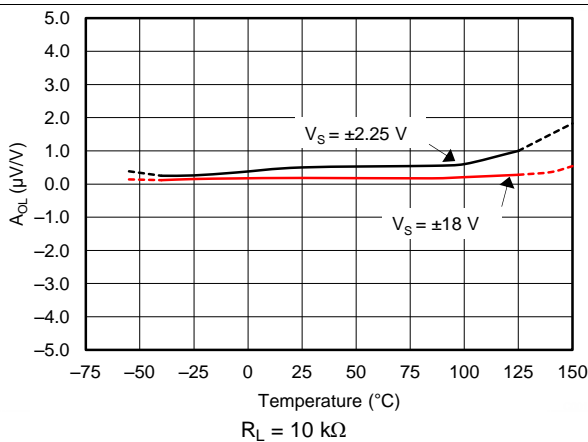


Figure 17. Open-Loop Gain vs Temperature

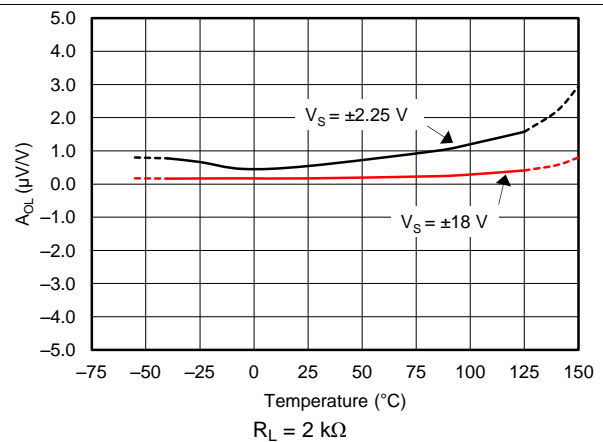


Figure 18. Open-Loop Gain vs Temperature

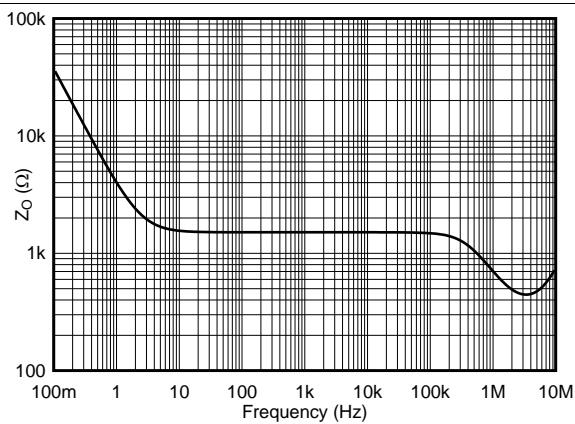


Figure 19. Open-Loop Output Impedance vs Frequency

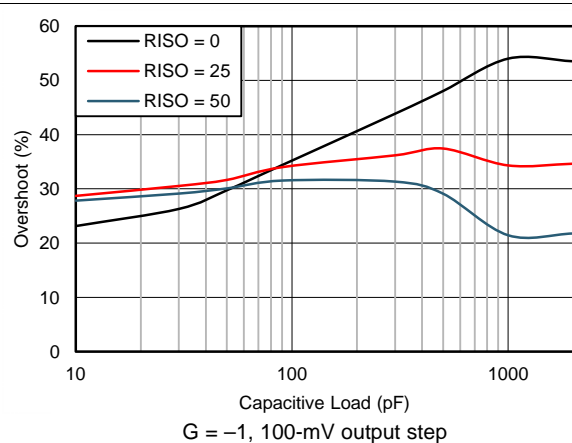


Figure 20. Small-Signal Overshoot vs Capacitive Load (100-mV Output Step)

At  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 18\text{ V}$ ,  $V_{CM} = V_S / 2$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$ , and  $C_L = 100\text{ pF}$ , unless otherwise noted.

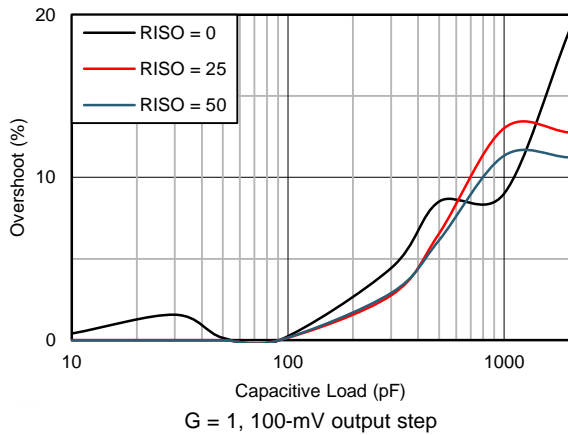


Figure 21. Small-Signal Overshoot vs Capacitive Load

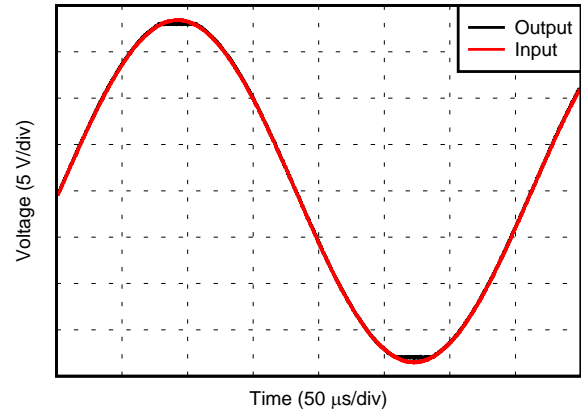


Figure 22. No Phase Reversal

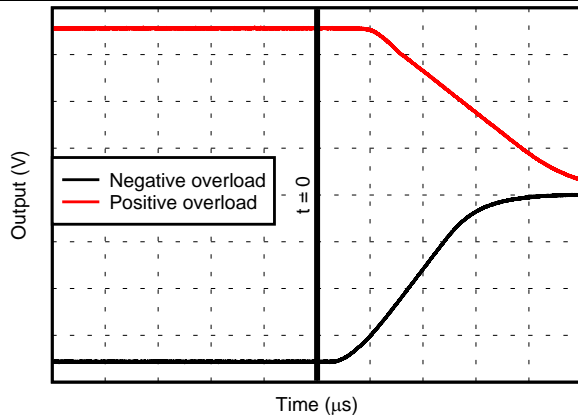


Figure 23. Overload Recovery

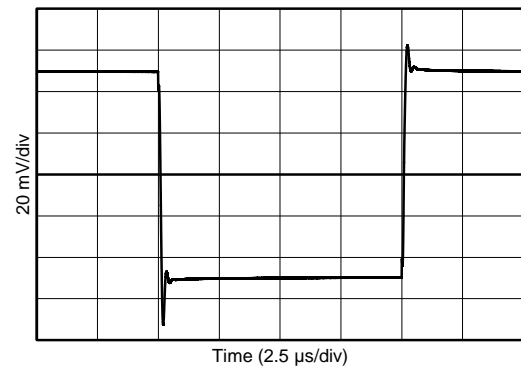


Figure 24. Small-Signal Step Response

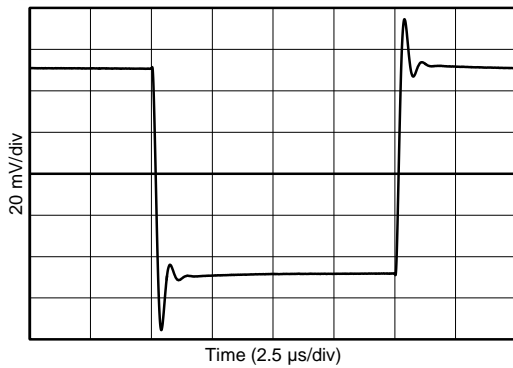


Figure 25. Small-Signal Step Response

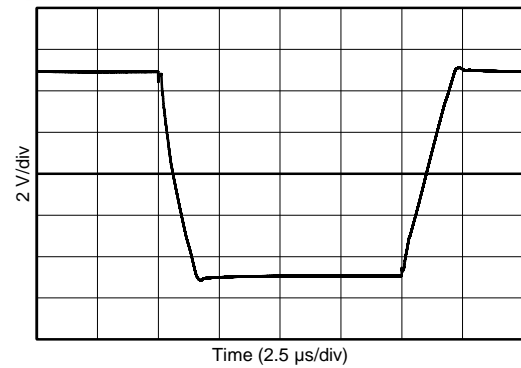
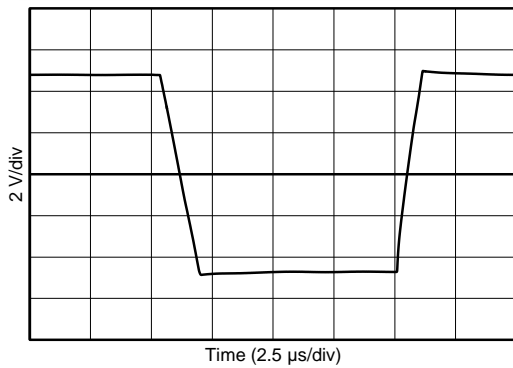


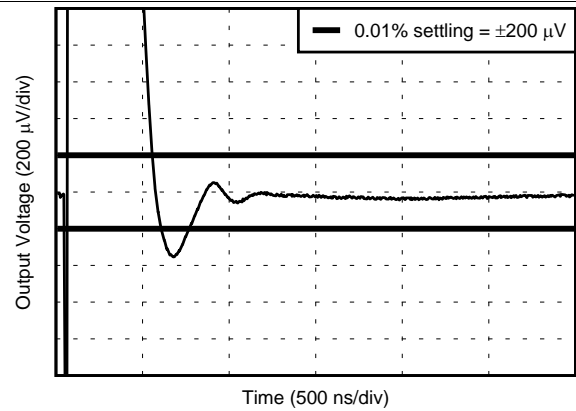
Figure 26. Large-Signal Step Response

At  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 18\text{ V}$ ,  $V_{CM} = V_S / 2$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$ , and  $C_L = 100\text{ pF}$ , unless otherwise noted.



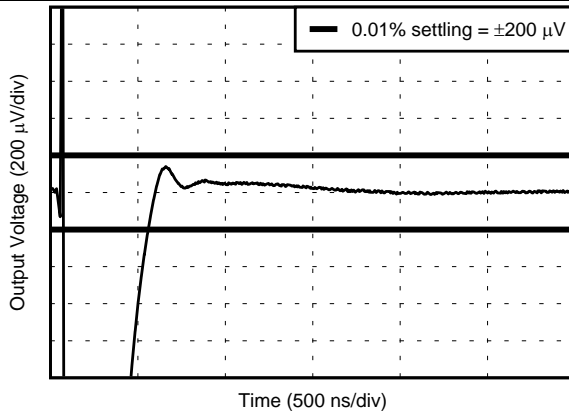
$G = -1$ ,  $R_L = 1\text{ k}\Omega$ ,  $C_L = 10\text{ pF}$

Figure 27. Large-Signal Step Response



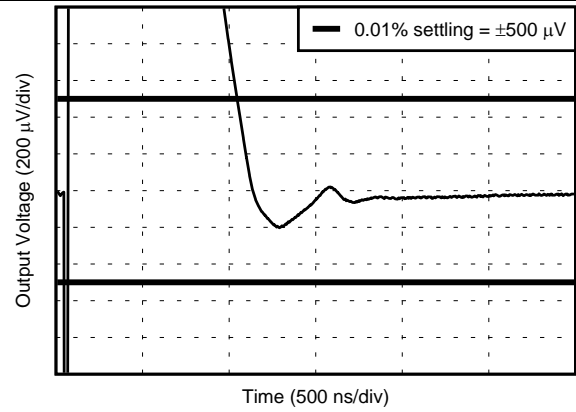
Gain = 1, 2-V step, rising, step applied at  $t = 0\ \mu\text{s}$  on all four plots

Figure 28. 0.01% Settling Time



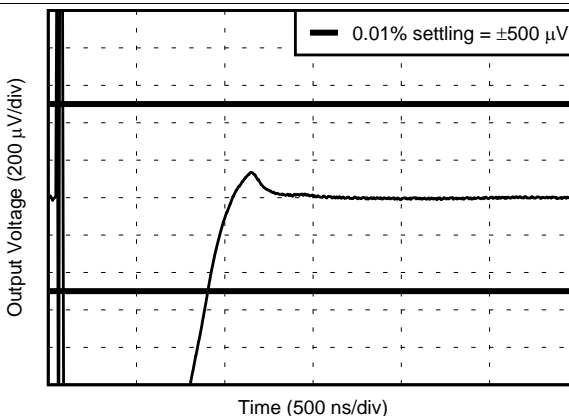
Gain = 1, 2-V step, falling, step applied at  $t = 0\ \mu\text{s}$

Figure 29. 0.01% Settling Time



Gain = 1, 5-V step, rising, step applied at  $t = 0\ \mu\text{s}$

Figure 30. 0.01% Settling Time



Gain = 1, 5-V step, falling, step applied at  $t = 0\ \mu\text{s}$

Figure 31. 0.01% Settling Time

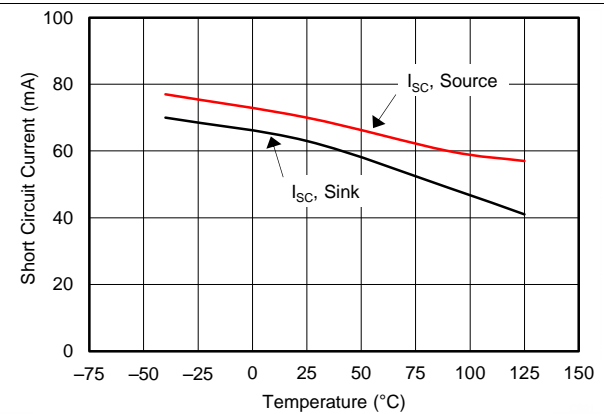
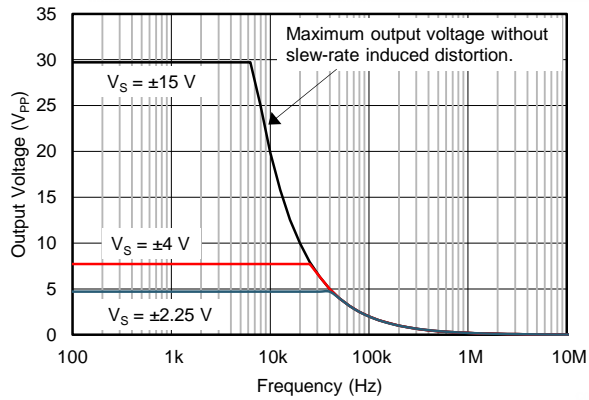


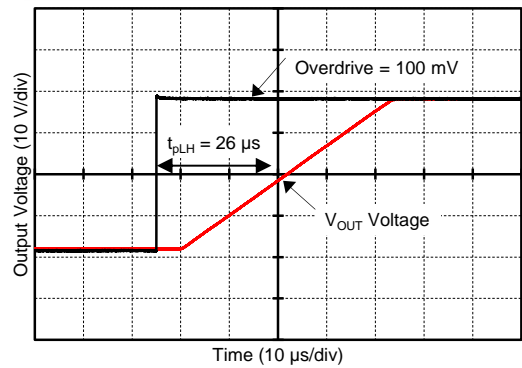
Figure 32. Short-Circuit Current vs Temperature



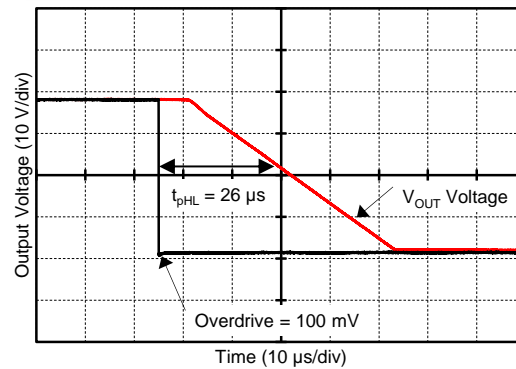
At  $T_A = 25^\circ\text{C}$ ,  $V_S = \pm 18\text{ V}$ ,  $V_{CM} = V_S / 2$ ,  $R_L = 10\text{ k}\Omega$  connected to  $V_S / 2$ , and  $C_L = 100\text{ pF}$ , unless otherwise noted.



**Figure 33. Maximum Output Voltage vs Frequency**



**Figure 34. Propagation Delay Rising Edge**



**Figure 35. Propagation Delay Falling Edge**

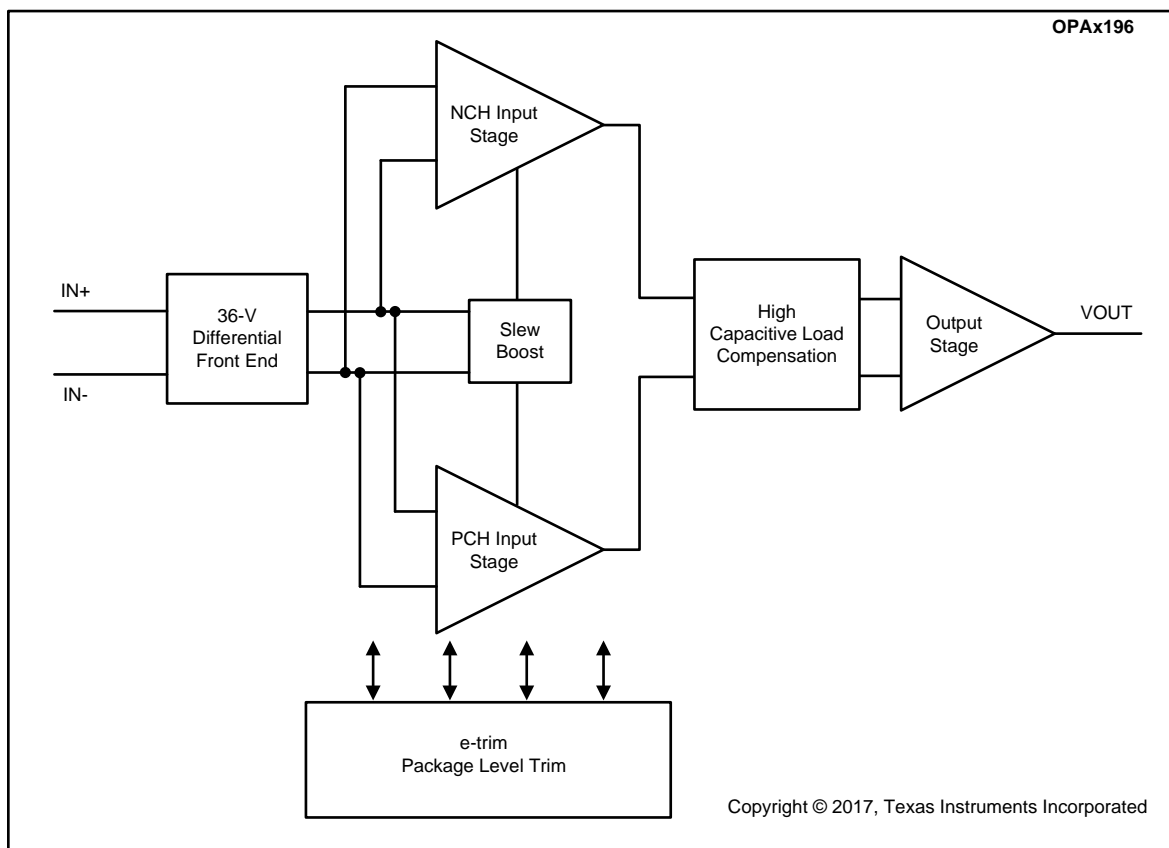
## 7 Detailed Description

### 7.1 Overview

The OPAx196 family of operational amplifiers use *e-trim*, a method of package-level trim for offset and offset temperature drift implemented during the final steps of manufacturing after the plastic molding process. This method minimizes the influence of inherent input transistor mismatch, as well as errors induced during package molding. The trim communication occurs on the output pin of the standard pinout, and after the trim points are set, further communication to the trim structure is permanently disabled. The [Functional Block Diagram](#) shows the simplified diagram of the OPA196 with e-trim.

Unlike previous e-trim op amps, the OPAx196 uses a patented two-temperature trim architecture to achieve a very low offset voltage and low voltage offset drift over the full specified temperature range. This level of precision performance at wide supply voltages makes these amplifiers useful for high-impedance industrial sensors, filters, and high-voltage data acquisition.

### 7.2 Functional Block Diagram



## 7.3 Feature Description

### 7.3.1 Input Protection Circuitry

The OPAx196 uses a unique input architecture to eliminate the need for input protection diodes but still provides robust input protection under transient conditions. Conventional input diode protection schemes shown in Figure 36 can be activated by fast transient step responses and can introduce signal distortion and settling time delays because of alternate current paths, as shown in Figure 37. For low-gain circuits, these fast-ramping input signals forward-bias back-to-back diodes that cause an increase in input current, resulting in extended settling time.

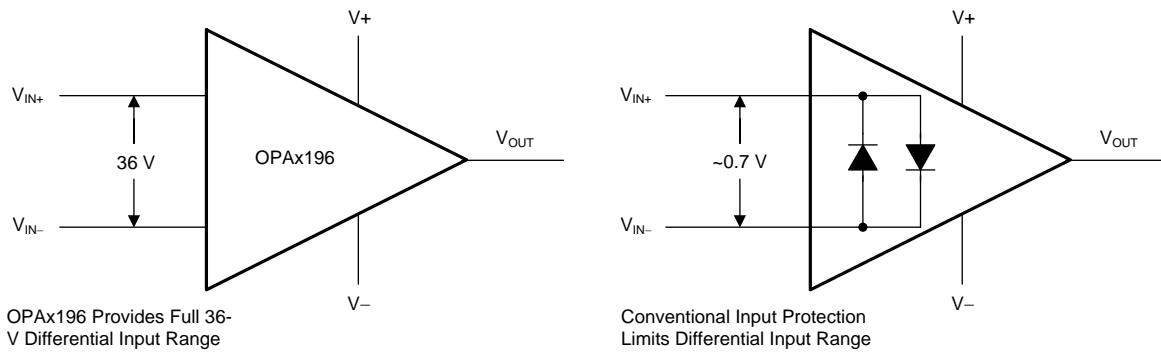


Figure 36. OPA196 Input Protection Does Not Limit Differential Input Capability

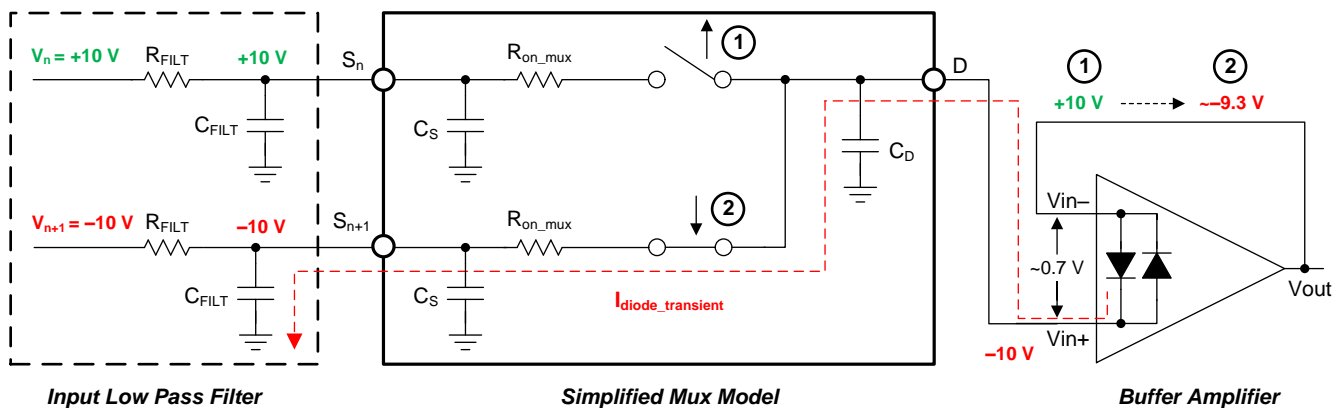


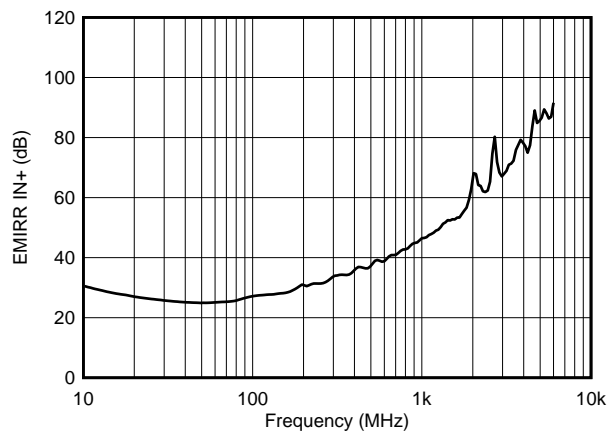
Figure 37. Back-to-Back Diodes Create Settling Issues

The OPAx196 family of operational amplifiers provides a true high-impedance differential input capability for high-voltage applications. This patented input protection architecture does not introduce additional signal distortion or delayed settling time, making the device an optimal op amp for multichannel, high-switched, input applications. The OPA196 can tolerate a maximum differential swing (voltage between inverting and noninverting pins of the op amp) of up to 36 V, making the device suitable for use as a comparator or in applications with fast-ramping input signals such as multiplexed data-acquisition systems (see Figure 49).

## Feature Description (continued)

### 7.3.2 EMI Rejection

The OPAx196 uses integrated electromagnetic interference (EMI) filtering to reduce the effects of EMI from sources such as wireless communications and densely-populated boards with a mix of analog signal chain and digital components. EMI immunity can be improved with circuit design techniques; the OPAx196 benefits from these design improvements. Texas Instruments has developed the ability to accurately measure and quantify the immunity of an operational amplifier over a broad frequency spectrum extending from 10 MHz to 6 GHz. [Figure 38](#) shows the results of this testing on the OPAx196. [Table 2](#) shows the EMIRR IN+ values for the OPAx196 at particular frequencies commonly encountered in real-world applications. Applications listed in [Table 2](#) may be centered on or operated near the particular frequency shown. Detailed information can also be found in the application report [EMI Rejection Ratio of Operational Amplifiers](#), available for download from [www.ti.com](http://www.ti.com).



$$P_{RF} = -10 \text{ dBm}, V_S = \pm 15 \text{ V}, V_{CM} = 0 \text{ V}$$

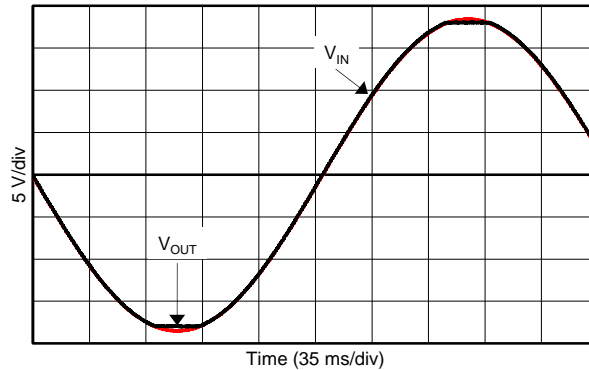
**Figure 38. EMIRR Testing**

**Table 2. OPA196 EMIRR IN+ For Frequencies of Interest**

| FREQUENCY | APPLICATION OR ALLOCATION  | EMIRR IN+ |
|-----------|--|-----------|
| 400 MHz   | Mobile radio, mobile satellite, space operation, weather, radar, ultra-high frequency (UHF) applications   | 36 dB     |
| 900 MHz   | Global system for mobile communications (GSM) applications, radio communication, navigation, GPS (to 1.6 GHz), GSM, aeronautical mobile, UHF applications                        | 45 dB     |
| 1.8 GHz   | GSM applications, mobile personal communications, broadband, satellite, L-band (1 GHz to 2 GHz)  | 57 dB     |
| 2.4 GHz   | 802.11b, 802.11g, 802.11n, Bluetooth®, mobile personal communications, industrial, scientific and medical (ISM) radio band, amateur radio and satellite, S-band (2 GHz to 4 GHz) | 62 dB     |
| 3.6 GHz   | Radiolocation, aero communication and navigation, satellite, mobile, S-band  | 76 dB     |
| 5.0 GHz   | 802.11a, 802.11n, aero communication and navigation, mobile communication, space and satellite operation, C-band (4 GHz to 8 GHz)  | 86 dB     |

### 7.3.3 Phase Reversal Protection

The OPAx196 family has internal phase-reversal protection. Many op amps exhibit phase reversal when the input is driven beyond the linear common-mode range. This condition is most often encountered in noninverting circuits when the input is driven beyond the specified common-mode voltage range, causing the output to reverse into the opposite rail. The OPAx196 is a rail-to-rail input op amp, and therefore the common-mode range can extend up to the rails. Input signals beyond the rails do not cause phase reversal; instead, the output limits into the appropriate rail. This performance is shown in [Figure 39](#).



**Figure 39. No Phase Reversal**

### 7.3.4 Thermal Protection

The internal power dissipation of any amplifier causes the internal (junction) temperature to rise. This phenomenon is called *self heating*. The OPAx196 has a thermal protection feature that prevents damage from self heating.

This thermal protection works by monitoring the temperature of the output stage and turning off the op amp output drive for temperatures above approximately 180°C. Thermal protection forces the output to a high-impedance state. The OPAx196 is also designed with approximately 30°C of thermal hysteresis. Thermal hysteresis prevents the output stage from cycling in and out of the high-impedance state. The OPAx196 returns to normal operation when the output stage temperature falls below approximately 150°C.

The absolute maximum junction temperature of the OPAx196 is 150°C. Exceeding the limits shown in the [Absolute Maximum Ratings](#) table may cause damage to the device. Thermal protection triggers at 180°C because of unit-to-unit variance, but does not interfere with device operation up to the absolute maximum ratings. This thermal protection is not designed to prevent this device from exceeding absolute maximum ratings, but rather from excessive thermal overload.

### 7.3.5 Capacitive Load and Stability

The OPAx196 features a patented output stage capable of driving large capacitive loads, and in a unity-gain configuration, directly drives up to 1 nF of pure capacitive load. Increasing the gain enhances the ability of the amplifier to drive greater capacitive loads; see Figure 40. The particular op amp circuit configuration, layout, gain, and output loading are some of the factors to consider when establishing whether an amplifier will be stable in operation.

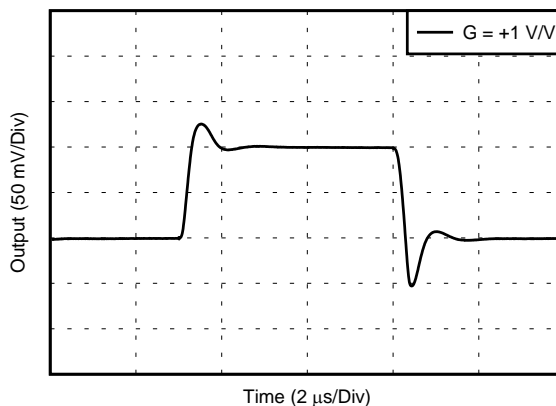


Figure 40. Transient Response with a Purely Capacitive Load of 1 nF

Like many low-power amplifiers, some ringing can occur even with capacitive loads less than 100 pF. In unity-gain configurations with no or very light dc loads, place an RC snubber circuit at the OPAx196 output to reduce any possibility of ringing in lightly-loaded applications. Figure 41 illustrates the recommended RC snubber circuit.

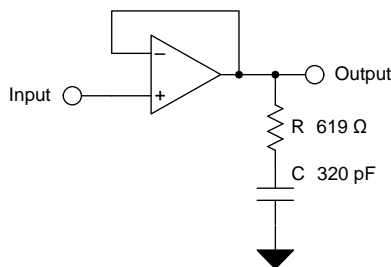
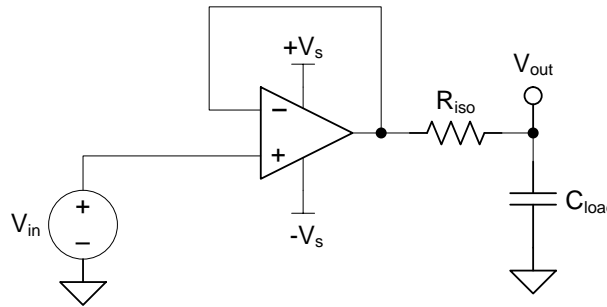


Figure 41. RC Snubber Circuit for Lightly-Loaded Applications in Unity Gain

For additional drive capability in unity-gain configurations, improve capacitive load drive by inserting a small, 10-Ω to 20-Ω resistor ( $R_{ISO}$ ) in series with the output, as shown in Figure 42. This resistor significantly reduces ringing while maintaining dc performance for purely capacitive loads. However, if there is a resistive load in parallel with the capacitive load, a voltage divider is created, introducing a gain error at the output and slightly reducing the output swing. The error introduced is proportional to the ratio  $R_{ISO} / R_L$  and is generally negligible at low output levels. A high capacitive load drive makes the OPA196 well suited for applications such as reference buffers, MOSFET gate drives, and cable-shield drives. The circuit shown in Figure 42 uses  $R_{ISO}$  to stabilize the output of an op amp.  $R_{ISO}$  modifies the open-loop gain of the system for increased phase margin. Results using the OPA196 are summarized in Table 3. For additional information on techniques to optimize and design using this circuit, TI Precision Design TIDU032 details complete design goals, simulation, and test results.



**Figure 42. Extending Capacitive Load Drive With the OPA196**

**Table 3. OPA196 Capacitive Load Drive Solution Using Isolation Resistor Comparison of Calculated and Measured Results**

| PARAMETER              | VALUE  |         |     |         |     |        |      |      |     |  |
|------------------------|--------|---------|-----|---------|-----|--------|------|------|-----|--|
|                        | 100 pF | 1000 pF |     | 0.01 μF |     | 0.1 μF |      | 1 μF |     |  |
| Phase Margin           | 45°    | 45°     | 60° | 45°     | 60° | 45°    | 60°  | 45°  | 60° |  |
| $R_{ISO}$ (Ω)          | 280    | 113     | 432 | 68      | 210 | 17.8   | 53.6 | 3.6  | 10  |  |
| Measured Overshoot (%) | 23     | 23      | 8   | 23      | 8   | 23     | 8    | 23   | 8   |  |



For step-by-step design procedure, circuit schematics, bill of materials, printed circuit board (PCB) files, simulation results, and test results, refer to [TI Precision Design TIDU032, Capacitive Load Drive Solution using an Isolation Resistor](#).

### 7.3.6 Common-Mode Voltage Range

The OPAx196 is a 36-V, true rail-to-rail input operational amplifier with an input common-mode range that extends 100 mV beyond either supply rail. This wide range is achieved with paralleled complementary N-channel and P-channel differential input pairs, as shown in Figure 43. The N-channel pair is active for input voltages close to the positive rail, typically  $(V+) - 3\text{ V}$  to 100 mV above the positive supply. The P-channel pair is active for inputs from 100 mV below the negative supply to approximately  $(V+) - 1.5\text{ V}$ . There is a small transition region, typically  $(V+) - 3\text{ V}$  to  $(V+) - 1.5\text{ V}$  in which both input pairs are active. This transition region varies modestly with process variation. Within this region PSRR, CMRR, offset voltage, offset drift, noise, and THD performance are degraded compared to operation outside this region.

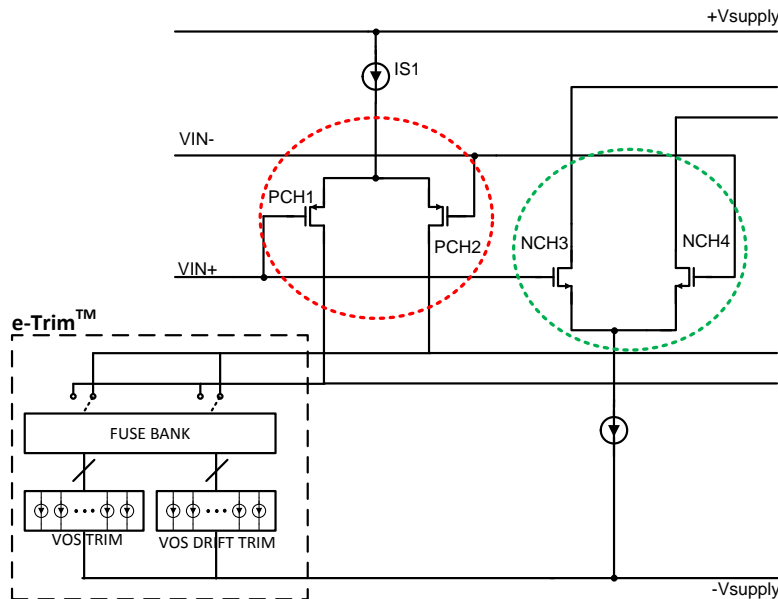


Figure 43. Rail-to-Rail Input Stage

To achieve the best performance for two-stage rail-to-rail input amplifiers, avoid the transition region when possible. The OPAx196 uses a precision trim for both the N-channel and P-channel regions. This technique enables significantly lower levels of offset than previous-generation devices, causing variance in the transition region of the input stages to appear exaggerated relative to offset over the full common-mode range, as shown in Figure 44.

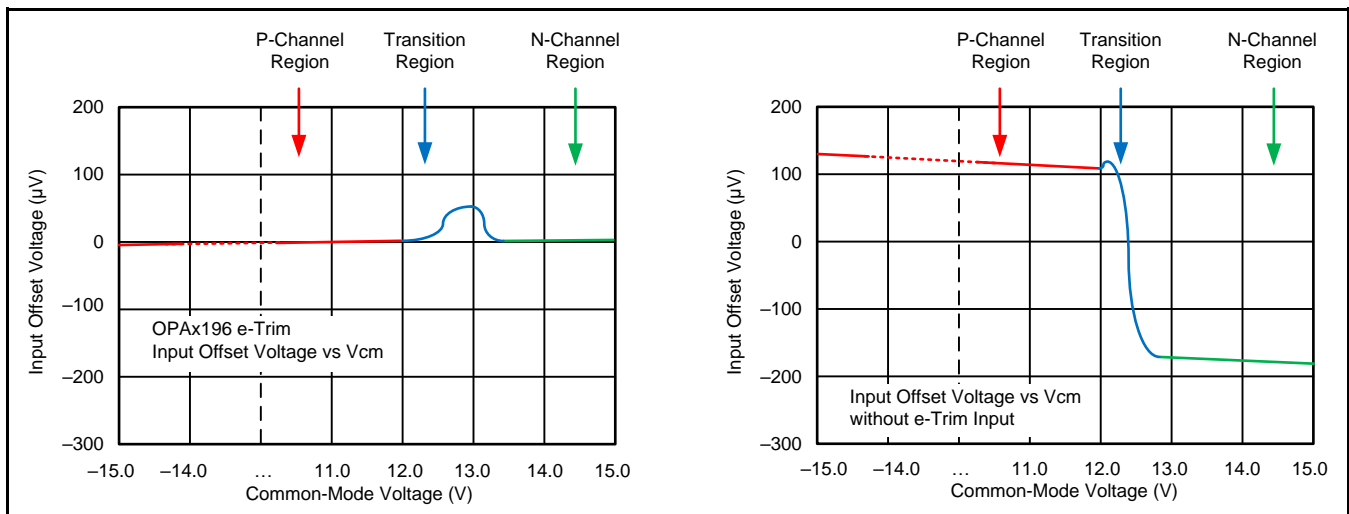


Figure 44. Common-Mode Transition vs Standard Rail-to-Rail Amplifiers



### 7.3.7 Electrical Overstress

Designers often ask questions about the capability of an operational amplifier to withstand electrical overstress (EOS). These questions tend to focus on the device inputs, but may involve the supply voltage pins or even the output pin. Each of these different pin functions have electrical stress limits determined by the voltage breakdown characteristics of the particular semiconductor fabrication process and specific circuits connected to the pin. Additionally, internal electrostatic discharge (ESD) protection is built into these circuits to protect them from accidental ESD events both before and during product assembly.

Having a good understanding of this basic ESD circuitry and its relevance to an electrical overstress event is helpful. See [Figure 45](#) for an illustration of the ESD circuits contained in the OPAx196 (indicated by the dashed line area). The ESD protection circuitry involves several current-steering diodes connected from the input and output pins and routed back to the internal power-supply lines, where the diodes meet at an absorption device or the power-supply ESD cell, internal to the operational amplifier. This protection circuitry is intended to remain inactive during normal circuit operation.

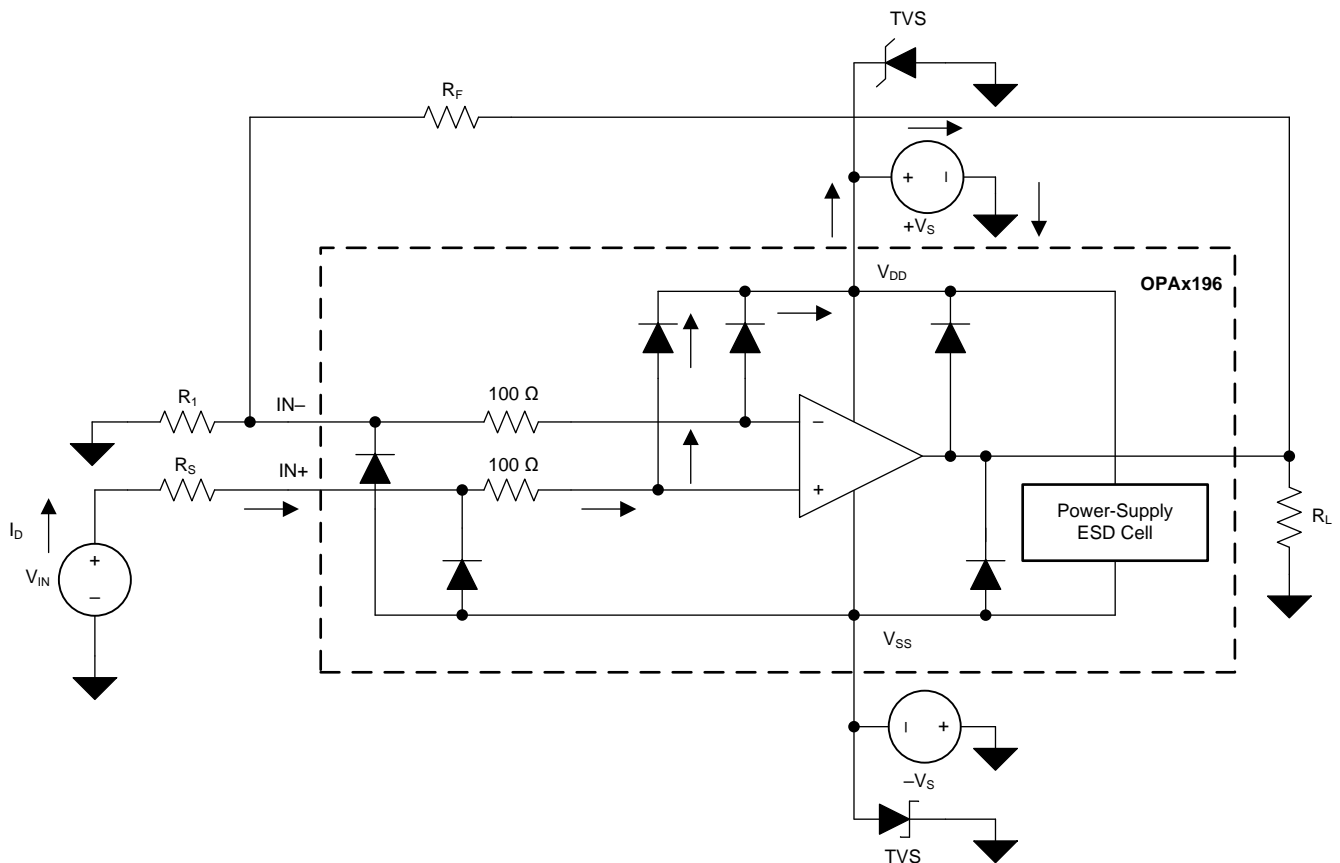


Figure 45. Equivalent Internal ESD Circuitry Relative to a Typical Circuit Application

An ESD event is very high voltage for a very short duration (for example, 1 kV for 100 ns); whereas, an EOS event is lower voltage for a longer duration (for example, 50 V for 100 ms). The ESD diodes are designed for out-of-circuit ESD protection (that is, during assembly, test, and storage of the device before being soldered to the PCB). During an ESD event, the ESD signal is passed through the ESD steering diodes to an absorption circuit labeled ESD power-supply circuit. The ESD absorption circuit clamps the supplies to a safe level.

Although this behavior is necessary for out-of-circuit protection, excessive current and damage is caused if activated in-circuit. A transient voltage suppressor (TVS) can be used to prevent against damage caused by turning on the ESD absorption circuit during an in-circuit ESD event. Using the appropriate current limiting resistors and TVS diodes allows for the use of device ESD diodes to protect against EOS events.

### 7.3.8 Overload Recovery

Overload recovery is defined as the time required for the op amp output to recover from a saturated state to a linear state. The output devices of the op amp enter a saturation region when the output voltage exceeds the rated operating voltage, either due to the high input voltage or the high gain. After the device enters the saturation region, the charge carriers in the output devices require time to return back to the linear state. After the charge carriers return back to the linear state, the device begins to slew at the specified slew rate. Thus, the propagation delay in case of an overload condition is the sum of the overload recovery time and the slew time.

## 7.4 Device Functional Modes

The OPAx196 has a single functional mode and is operational when the power-supply voltage is greater than 4.5 V ( $\pm 2.25$  V). The maximum power supply voltage for the OPAx196 is 36 V ( $\pm 18$  V).

## 8 Application and Implementation

### NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

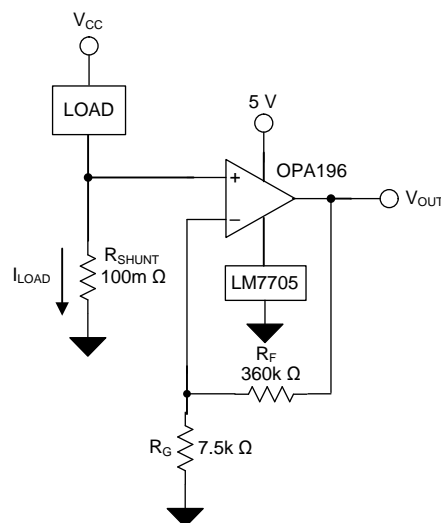
### 8.1 Application Information

The OPAx196 family offers outstanding dc precision and ac performance. These devices operate up to 36-V supply rails and offer true rail-to-rail input/output, ultralow offset voltage and offset voltage drift, as well as 2-MHz bandwidth and high capacitive load drive. These features make the OPAx196 a robust, high-performance operational amplifier for high-voltage industrial applications.

### 8.2 Typical Applications

#### 8.2.1 Low-side Current Measurement

Figure 46 shows the OPA196 configured in a low-side current sensing application. For a full analysis of the circuit shown in Figure 46 including theory, calculations, simulations, and measured data see the 0-1A, single-supply, low-side, current sensing solution, see TIPD129.



**Figure 46. OPA196 in a Low-Side, Current-Sensing Application**

#### 8.2.1.1 Design Requirements

The design requirements for this design are:

- Load current: 0 A to 1 A
- Output voltage: 4.9 V
- Maximum shunt voltage: 100 mV

## Typical Applications (continued)

### 8.2.1.2 Detailed Design Procedure

The transfer function of the circuit in [Figure 46](#) is given in [Equation 1](#):

$$V_{OUT} = I_{LOAD} \times R_{SHUNT} \times \text{Gain} \quad (1)$$

The load current ( $I_{LOAD}$ ) produces a voltage drop across the shunt resistor ( $R_{SHUNT}$ ). The load current is set from 0 A to 1 A. To keep the shunt voltage below 100 mV at maximum load current, the largest shunt resistor is defined using [Equation 2](#).

$$R_{SHUNT} = \frac{V_{SHUNT\_MAX}}{I_{LOAD\_MAX}} = \frac{100\text{mV}}{1\text{A}} = 100\text{m}\Omega \quad (2)$$

Using [Equation 2](#),  $R_{SHUNT}$  is calculated to be 100 m $\Omega$ . The voltage drop produced by  $I_{LOAD}$  and  $R_{SHUNT}$  is amplified by the OPA196 to produce an output voltage of 0 V to 4.9 V. The gain needed by the OPA196 to produce the necessary output voltage is calculated using [Equation 3](#):

$$\text{Gain} = \frac{(V_{OUT\_MAX} - V_{OUT\_MIN})}{(V_{IN\_MAX} - V_{IN\_MIN})} \quad (3)$$

Using [Equation 3](#), the required gain is calculated to be 49 V/V, which is set with resistors  $R_F$  and  $R_G$ . [Equation 4](#) is used to size the resistors,  $R_F$  and  $R_G$ , to set the gain of the OPA196 to 49 V/V.

$$\text{Gain} = 1 + \frac{(R_F)}{(R_G)} \quad (4)$$

Choosing  $R_F$  as 360 k $\Omega$ ,  $R_G$  is calculated to be 7.5 k $\Omega$ .  $R_F$  and  $R_G$  were chosen as 360 k $\Omega$  and 7.5 k $\Omega$  because they are standard value resistors that create a 49:1 ratio. Other resistors that create a 49:1 ratio can also be used. [Figure 2](#) shows the measured transfer function of the circuit shown in [Figure 46](#).

### 8.2.1.3 Application Curves

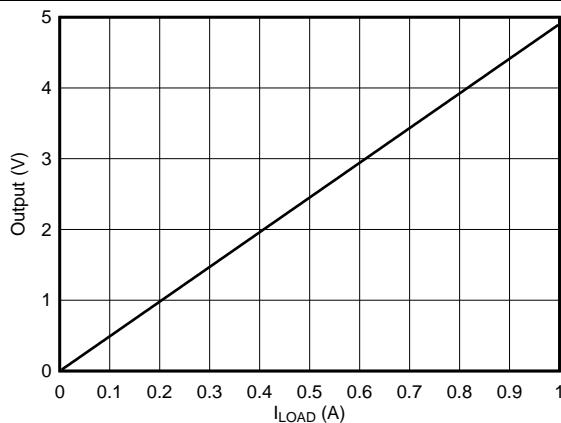


Figure 47. Low-Side, Current-Sense, Transfer Function

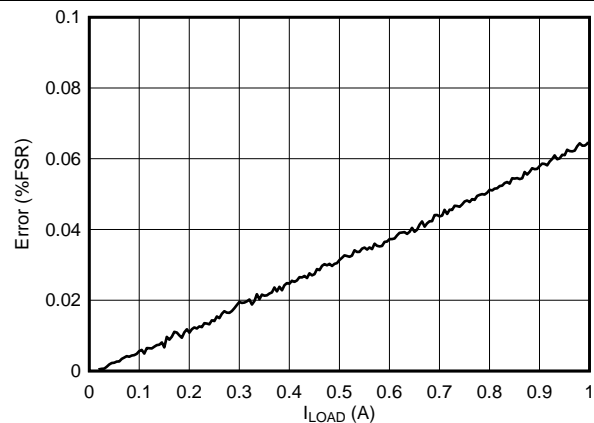


Figure 48. Low-Side, Current-Sense, Full-Scale Error

## Typical Applications (continued)

### 8.2.2 16-Bit Precision Multiplexed Data-Acquisition System

Figure 49 shows a 16-bit, differential, 4-channel, multiplexed, data-acquisition system. This example is typical in industrial applications that require low distortion and a high-voltage differential input. The circuit uses the ADS8864, a 16-bit, 400-kSPS successive-approximation-resistor (SAR), analog-to-digital converter (ADC), along with a precision, high-voltage, signal-conditioning front-end, and a 4-channel differential multiplexer (mux). This application example shows the process for optimizing the precision, high-voltage, front-end drive circuit using the OPA196 and OPA140 to achieve excellent dynamic performance and linearity with the ADS8864. The full TI Precision Design can be found in TIDU181.

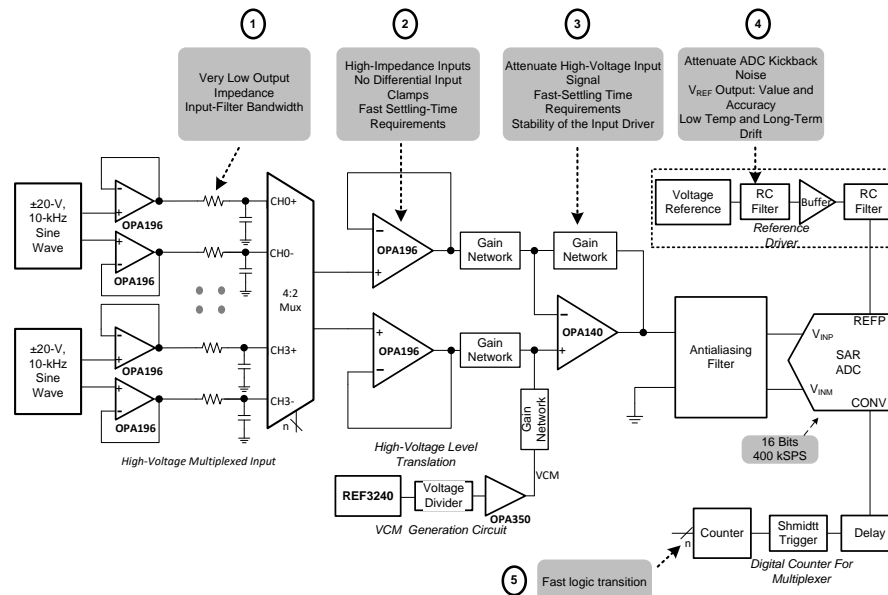


Figure 49. OPA196 in 16-Bit, 400-kSPS, 4-Channel, Multiplexed Data Acquisition System for High-Voltage Inputs With Lowest Distortion

#### 8.2.2.1 Design Requirements

The primary objective is to design a  $\pm 20$ -V, differential, 4-channel, multiplexed, data acquisition system with lowest distortion using the 16-bit ADS8864 at a throughput of 400 kSPS for a 10-kHz, full-scale, pure sine-wave input. The design requirements for this block design are:

- System supply voltage:  $\pm 15$  V
- ADC supply voltage: 3.3 V
- ADC sampling rate: 400 kSPS
- ADC reference voltage (REFP): 4.096 V
- System input signal: A high-voltage differential input signal with a peak amplitude of 10 V and frequency ( $f_{IN}$ ) of 10 kHz are applied to each differential input of the mux.

#### 8.2.2.2 Detailed Design Procedure

The purpose of this application example is to design an optimal, high-voltage, multiplexed, data-acquisition system for highest system linearity and fast settling. The overall system block diagram is shown in Figure 49. The circuit is a multichannel, data-acquisition, signal chain consisting of an input low-pass filter, multiplexer (mux), mux output buffer, attenuating SAR ADC driver, digital counter for the mux, and the reference driver. The architecture allows fast sampling of multiple channels using a single ADC, providing a low-cost solution. The two primary design considerations to maximize the performance of a precision, multiplexed, data-acquisition system are the mux input analog front-end and the high-voltage, level translation, SAR ADC driver design. However, carefully design each analog circuit block based on the ADC performance specifications in order to achieve the fastest settling at 16-bit resolution and lowest distortion system. Figure 49 includes the most important specifications for each individual analog block.

## Typical Applications (continued)

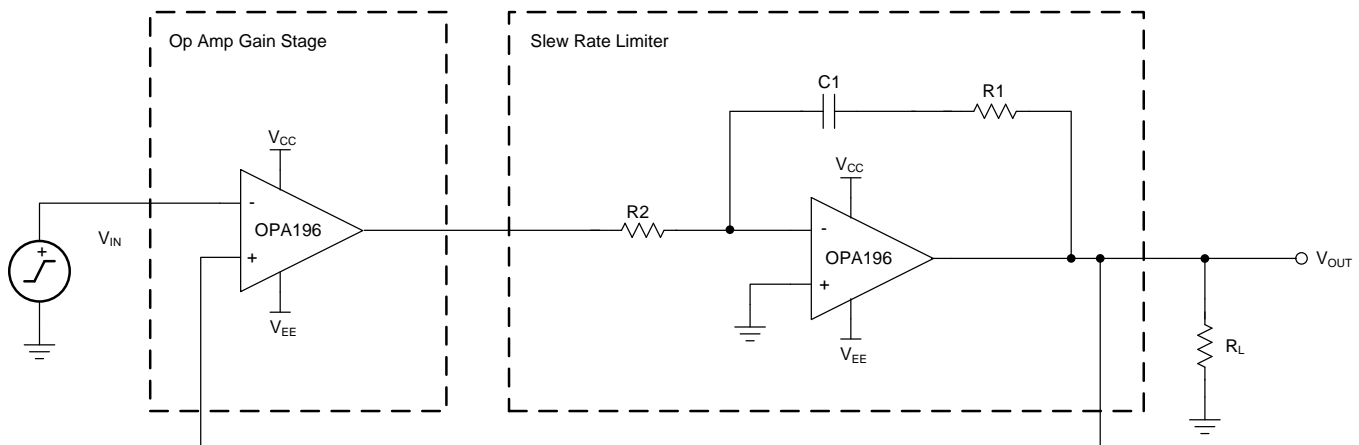
This design systematically approaches each analog circuit block to achieve a 16-bit settling for a full-scale input stage voltage and linearity for a 10-kHz sinusoidal input signal at each input channel. The first step in the design is to understand the requirement for an extremely-low-impedance input-filter design for the mux. This understanding helps in the decision of an appropriate input filter and selection of a mux to meet the system settling requirements. The next important step is the design of the attenuating analog front-end (AFE) used to level translate the high-voltage input signal to a low-voltage ADC input while maintaining the amplifier stability. Then, the next step is to design a digital interface to switch the mux input channels with minimum delay. The final design challenge is to design a high-precision, reference-driver circuit that provides the required REFP reference voltage with low offset, drift, and noise contributions.



For step-by-step design procedure, circuit schematics, bill of materials, PCB files, simulation results, and test results, refer to [TI Precision Design TIDU181, 16-bit, 400-kSPS, 4-Channel, Multiplexed Data Acquisition System for High Voltage Inputs with Lowest Distortion.](#)

### 8.2.3 Slew Rate Limit for Input Protection

In control systems for valves or motors, abrupt changes in voltages or currents can cause mechanical damages. By controlling the slew rate of the command voltages into the drive circuits, the load voltages ramps up and down at a safe rate. For symmetrical slew-rate applications (positive slew rate equals negative slew rate), one additional op amp provides slew-rate control for a given analog gain stage. The unique input protection and high output current and slew rate of the OPAx196 make the device an optimal amplifier to achieve slew rate control for both dual- and single-supply systems. [Figure 50](#) shows the OPA196 in a slew-rate limit design.



**Figure 50. Slew Rate Limiter Uses One Op Amp**



For step-by-step design procedure, circuit schematics, bill of materials, PCB files, simulation results, and test results, refer to [TI Precision Design TIDU026, Slew Rate Limiter Uses One Op Amp.](#)

## 9 Power-Supply Recommendations

The OPAx196 is specified for operation from 4.5 V to 36 V ( $\pm 2.25$  V to  $\pm 18$  V); many specifications apply from  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ . Parameters that can exhibit significant variance with regard to operating voltage or temperature are presented in the [Typical Characteristics](#).

### CAUTION

Supply voltages larger than 40 V can permanently damage the device; see the [Absolute Maximum Ratings](#).

Place 0.1- $\mu\text{F}$  bypass capacitors close to the power-supply pins to reduce errors coupling in from noisy or high-impedance power supplies. For more detailed information on bypass capacitor placement, refer to the [Layout](#) section.

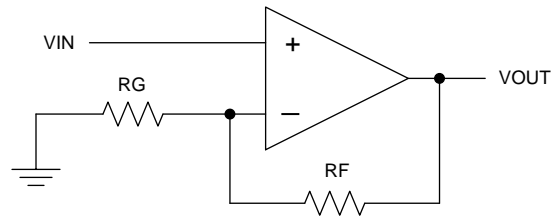
## 10 Layout

### 10.1 Layout Guidelines

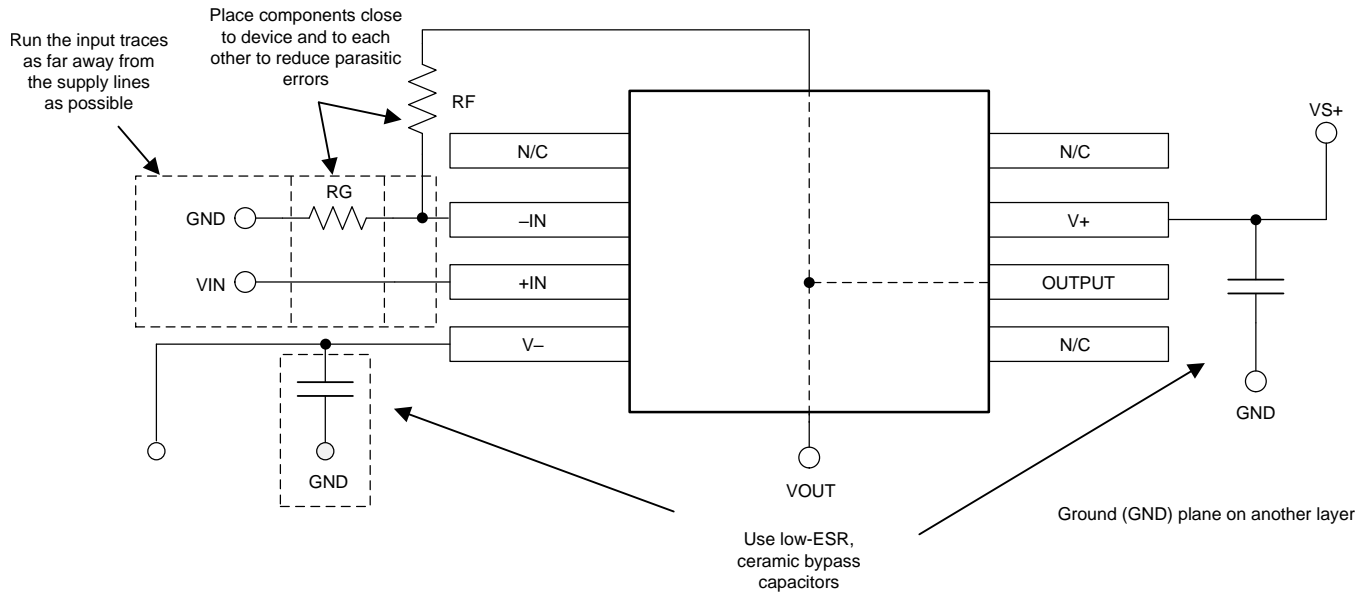
For best operational performance of the device, use good PCB layout practices, including:

- Connect low-ESR, 0.1- $\mu\text{F}$  ceramic bypass capacitors between each supply pin and ground, placed as close as possible to the device. A single bypass capacitor from V+ to ground is applicable for single-supply applications.
  - Noise can propagate into analog circuitry through the power pins of the circuit as a whole and op amp itself. Bypass capacitors are used to reduce the coupled noise by providing low-impedance power sources local to the analog circuitry.
- Make sure to physically separate digital and analog grounds paying attention to the flow of the ground current. Separate grounding for analog and digital portions of circuitry is one of the simplest and most-effective methods of noise suppression. One or more layers on multilayer PCBs are usually devoted to ground planes. A ground plane helps distribute heat and reduces EMI noise pickup.
- In order to reduce parasitic coupling, run the input traces as far away as possible from the supply or output traces. If these traces cannot be kept separate, crossing the sensitive trace perpendicular is much better as opposed to in parallel with the noisy trace.
- Place the external components as close to the device as possible. As shown in [Figure 52](#), keeping RF and RG close to the inverting input minimizes parasitic capacitance.
- Keep the length of input traces as short as possible. Always remember that the input traces are the most sensitive part of the circuit.
- Consider a driven, low-impedance guard ring around the critical traces. A guard ring can significantly reduce leakage currents from nearby traces that are at different potentials.
- Clean the PCB following board assembly for best performance.
- Any precision integrated circuit may experience performance shifts due to moisture ingress into the plastic package. After any aqueous PCB cleaning process, bake the PCB assembly to remove moisture introduced into the device packaging during the cleaning process. A low-temperature, post-cleaning bake at  $85^{\circ}\text{C}$  for 30 minutes is sufficient for most circumstances.

## 10.2 Layout Example



**Figure 51. Schematic Representation**



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**Figure 52. Operational Amplifier Board Layout for Non-inverting Configuration**



## 11 器件和文档支持

### 11.1 器件支持

#### 11.1.1 开发支持

##### 11.1.1.1 TINA-TI™ (免费软件下载)

TINA™是一款简单、功能强大且易于使用的电路仿真程序，此程序基于 SPICE 引擎。TINA-TI 是 TINA 软件的一款免费全功能版本，除了一系列无源和有源模型外，此版本软件还预先载入了一个宏模型库。TINA-TI 提供所有传统的 SPICE 直流、瞬态和频域分析，以及其他设计功能。

TINA-TI 可从 Analog eLab Design Center (模拟电子实验室设计中心) [免费下载](#)，它提供全面的后续处理能力，使得用户能够以多种方式形成结果。虚拟仪器提供选择输入波形和探测电路节点、电压以及波形的功能，从而构建一个动态的快速入门工具。

**注**

这些文件需要安装 TINA 软件 (由 DesignSoft™提供) 或者 TINA-TI 软件。请从 [TINA-TI](#) 文件夹中下载免费的 TINA-TI 软件 (网址为 <http://www.ti.com.cn/tool/cn/tina-ti>)。

##### 11.1.1.2 TI 高精度设计

TI 高精度设计 (请访问 <http://www.ti.com.cn/ww/analog/precision-designs/> 获取) 是由 TI 公司高精度模拟应用专家创建的模拟解决方案，提供了许多实用电路的工作原理、组件选择、仿真、完整印刷电路板 (PCB) 电路原理图和布局布线、物料清单以及性能测量结果。

### 11.2 文档支持

#### 11.2.1 相关文档

- [《运算放大器的电磁干扰 \(EMI\) 抑制比》](#)
- [0-1A 单电源低侧电流传感解决方案](#)
- [《适合所有人的运算放大器》](#)

#### 11.3 相关链接

**表 4** 列出了快速访问链接。类别包括技术文档、支持和社区资源、工具和软件，以及立即购买的快速链接。

**表 4. 相关链接**

| 器件      | 产品文件夹                 | 立即订购                  | 技术文档                  | 工具和软件                 | 支持和社区                 |
|---------|-----------------------|-----------------------|-----------------------|-----------------------|-----------------------|
| OPA196  | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> |
| OPA2196 | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> |
| OPA4196 | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> | <a href="#">请单击此处</a> |

#### 11.4 接收文档更新通知

要接收文档更新通知，请导航至 [Ti.com](http://ti.com) 上的器件产品文件夹。请单击右上角的 [通知我](#) 进行注册，即可收到任意产品信息更改每周摘要。有关更改的详细信息，请查看任意已修订文档中包含的修订历史记录。

## 11.5 社区资源

下列链接提供到 TI 社区资源的连接。链接的内容由各个分销商“按照原样”提供。这些内容并不构成 TI 技术规范，并且不一定反映 TI 的观点；请参阅 TI 的《使用条款》。

**TI E2E™ 在线社区** *TI 的工程师对工程师 (E2E) 社区*。此社区的创建目的在于促进工程师之间的协作。在 e2e.ti.com 中，您可以咨询问题、分享知识、拓展思路并与同行工程师一道帮助解决问题。

**设计支持** *TI 参考设计支持* 可帮助您快速查找有帮助的 E2E 论坛、设计支持工具以及技术支持的联系信息。

## 11.6 商标

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Bluetooth is a registered trademark of Bluetooth SIG, Inc.

TINA, DesignSoft are trademarks of DesignSoft, Inc.

## 11.7 静电放电警告



ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序，可能会损坏集成电路。

ESD 的损坏小至导致微小的性能降级，大至整个器件故障。精密的集成电路可能更容易受到损坏，这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

## 11.8 Glossary

**SLYZ022** — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

## 12 机械、封装和可订购信息

以下页面包括机械、封装和可订购信息。这些信息是指定器件的最新可用数据。这些数据发生变化时，我们可能不会另行通知或修订此文档。如欲获取此产品说明书的浏览器版本，请参见左侧的导航栏。

**PACKAGING INFORMATION**

| Orderable Device | Status<br>(1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan<br>(2) | Lead finish/<br>Ball material<br>(6) | MSL Peak Temp<br>(3) | Op Temp (°C) | Device Marking<br>(4/5) | Samples                 |
|------------------|---------------|--------------|-----------------|------|-------------|-----------------|--------------------------------------|----------------------|--------------|-------------------------|-------------------------|
| OPA196ID         | ACTIVE        | SOIC         | D               | 8    | 75          | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | OPA196                  | <a href="#">Samples</a> |
| OPA196IDBVR      | ACTIVE        | SOT-23       | DBV             | 5    | 3000        | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | O196                    | <a href="#">Samples</a> |
| OPA196IDBVT      | ACTIVE        | SOT-23       | DBV             | 5    | 250         | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | O196                    | <a href="#">Samples</a> |
| OPA196IDGKR      | ACTIVE        | VSSOP        | DGK             | 8    | 2500        | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | O196                    | <a href="#">Samples</a> |
| OPA196IDGKT      | ACTIVE        | VSSOP        | DGK             | 8    | 250         | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | O196                    | <a href="#">Samples</a> |
| OPA196IDR        | ACTIVE        | SOIC         | D               | 8    | 2500        | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | OPA196                  | <a href="#">Samples</a> |
| OPA2196ID        | ACTIVE        | SOIC         | D               | 8    | 75          | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | OP2196                  | <a href="#">Samples</a> |
| OPA2196IDGKR     | ACTIVE        | VSSOP        | DGK             | 8    | 2500        | RoHS & Green    | Call TI   NIPDAU                     | Level-2-260C-1 YEAR  | -40 to 125   | 2196                    | <a href="#">Samples</a> |
| OPA2196IDGKT     | ACTIVE        | VSSOP        | DGK             | 8    | 250         | RoHS & Green    | Call TI   NIPDAU                     | Level-2-260C-1 YEAR  | -40 to 125   | 2196                    | <a href="#">Samples</a> |
| OPA2196IDR       | ACTIVE        | SOIC         | D               | 8    | 2500        | RoHS & Green    | NIPDAU                               | Level-2-260C-1 YEAR  | -40 to 125   | OP2196                  | <a href="#">Samples</a> |
| OPA4196ID        | ACTIVE        | SOIC         | D               | 14   | 50          | RoHS & Green    | NIPDAU                               | Level-3-260C-168 HR  | -40 to 125   | OPA4196                 | <a href="#">Samples</a> |
| OPA4196IDR       | ACTIVE        | SOIC         | D               | 14   | 2500        | RoHS & Green    | NIPDAU                               | Level-3-260C-168 HR  | -40 to 125   | OPA4196                 | <a href="#">Samples</a> |

(1) The marketing status values are defined as follows:

**ACTIVE:** Product device recommended for new designs.

**LIFEBUY:** TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

**NRND:** Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

**PREVIEW:** Device has been announced but is not in production. Samples may or may not be available.

**OBSELETE:** TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

**RoHS Exempt:** TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

**Green:** TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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D0014A



# PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



4220718/A 09/2016

NOTES:

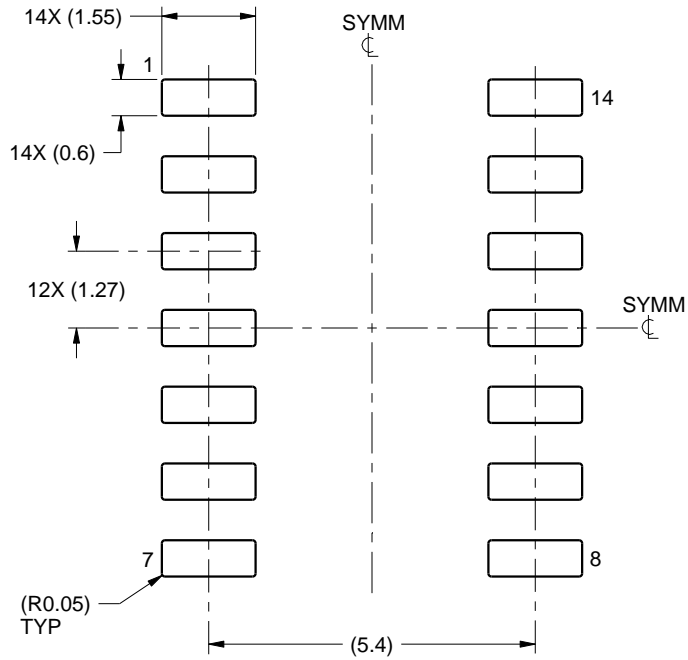
1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm, per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm, per side.
5. Reference JEDEC registration MS-012, variation AB.

# EXAMPLE BOARD LAYOUT

D0014A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE  
SCALE:8X



SOLDER MASK DETAILS

4220718/A 09/2016

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

D0014A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:8X

4220718/A 09/2016

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



D0008A

# PACKAGE OUTLINE

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



NOTES:

1. Linear dimensions are in inches [millimeters]. Dimensions in parenthesis are for reference only. Controlling dimensions are in inches. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed  $.006$  [0.15] per side.
4. This dimension does not include interlead flash.
5. Reference JEDEC registration MS-012, variation AA.



# EXAMPLE BOARD LAYOUT

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



LAND PATTERN EXAMPLE  
 EXPOSED METAL SHOWN  
 SCALE:8X



SOLDER MASK DETAILS

4214825/C 02/2019

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

D0008A

SOIC - 1.75 mm max height

SMALL OUTLINE INTEGRATED CIRCUIT



SOLDER PASTE EXAMPLE  
BASED ON .005 INCH [0.125 MM] THICK STENCIL  
SCALE:8X

4214825/C 02/2019

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.



# EXAMPLE BOARD LAYOUT

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE:15X



SOLDER MASK DETAILS

4214839/K 08/2024

NOTES: (continued)

- 6. Publication IPC-7351 may have alternate designs.
- 7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

# EXAMPLE STENCIL DESIGN

DBV0005A

SOT-23 - 1.45 mm max height

SMALL OUTLINE TRANSISTOR



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL  
SCALE:15X

4214839/K 08/2024

NOTES: (continued)

8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
9. Board assembly site may have different recommendations for stencil design.

# DGK0008A



# PACKAGE OUTLINE

VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



4214862/A 04/2023

**NOTES:**

PowerPAD is a trademark of Texas Instruments.

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not exceed 0.15 mm per side.
4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
5. Reference JEDEC registration MO-187.

# EXAMPLE BOARD LAYOUT

DGK0008A

™ VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



LAND PATTERN EXAMPLE  
EXPOSED METAL SHOWN  
SCALE: 15X



SOLDER MASK DETAILS

4214862/A 04/2023

NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.
7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.
8. Vias are optional depending on application, refer to device data sheet. If any vias are implemented, refer to their locations shown on this view. It is recommended that vias under paste be filled, plugged or tented.
9. Size of metal pad may vary due to creepage requirement.

# EXAMPLE STENCIL DESIGN

DGK0008A

<sup>TM</sup> VSSOP - 1.1 mm max height

SMALL OUTLINE PACKAGE



SOLDER PASTE EXAMPLE  
SCALE: 15X

4214862/A 04/2023

NOTES: (continued)

11. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
12. Board assembly site may have different recommendations for stencil design.



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